

Extended images in action

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Motivation

Computation of *full*-subsurface offset volumes is computationally *prohibitively* expensive (storage & computation time)

Full-subsurface *offset* volumes allow us to conduct

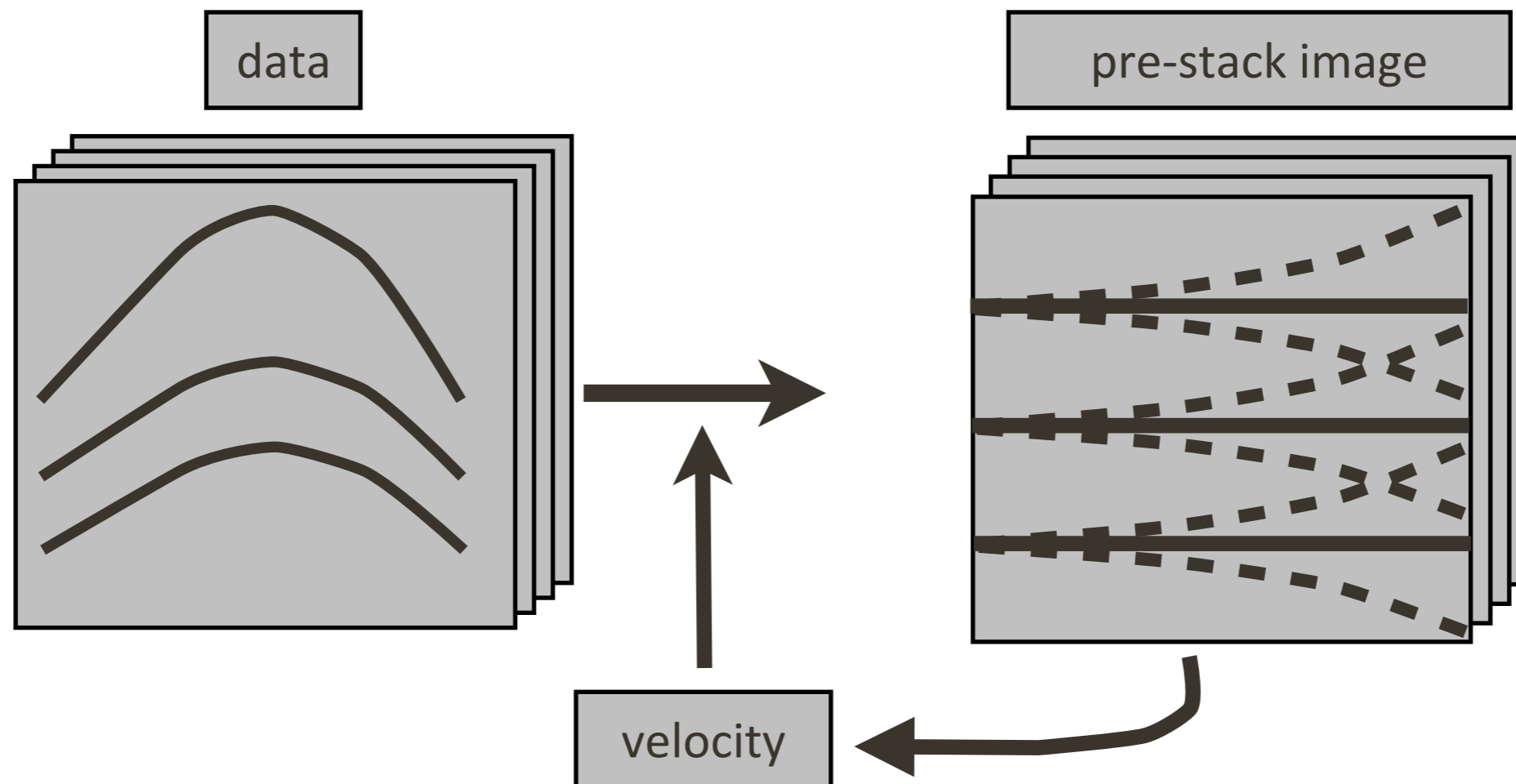
- ▶ MVA
- ▶ AVA w/ geologic *dip* corrections

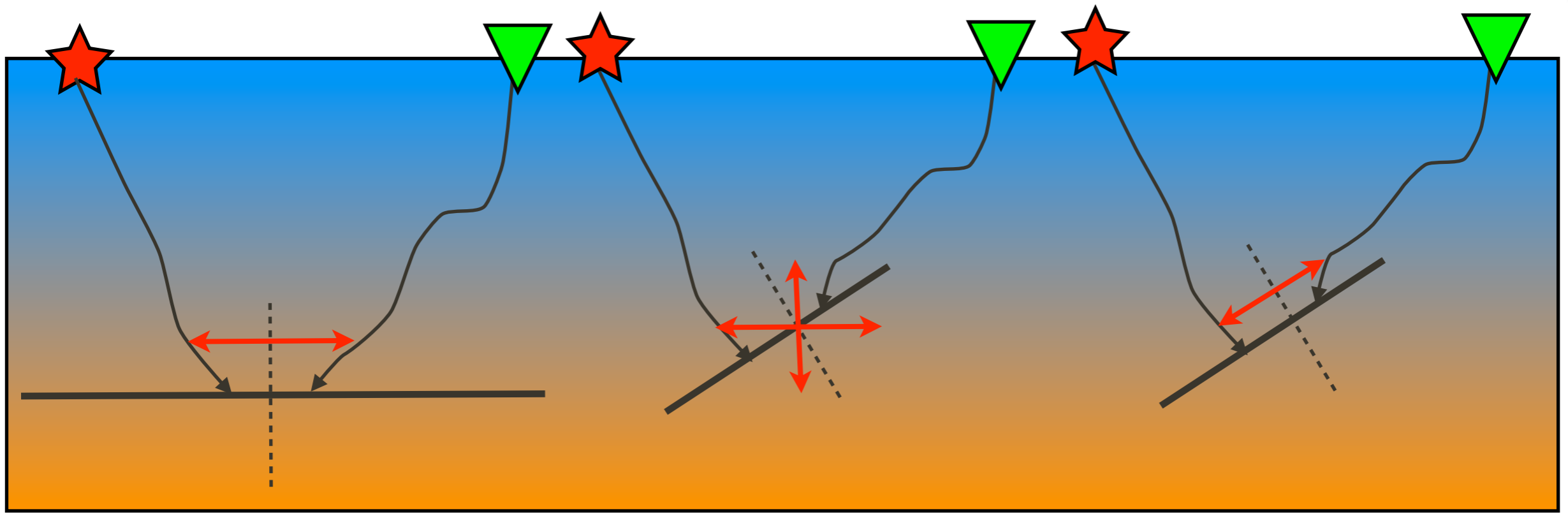
using information from *all* directions.

Use *probing* techniques we used *successfully* in *FWI*...

Migration-velocity analysis

- find *starting* model for FWI?
- *invert* kinematic errors in *image* volumes





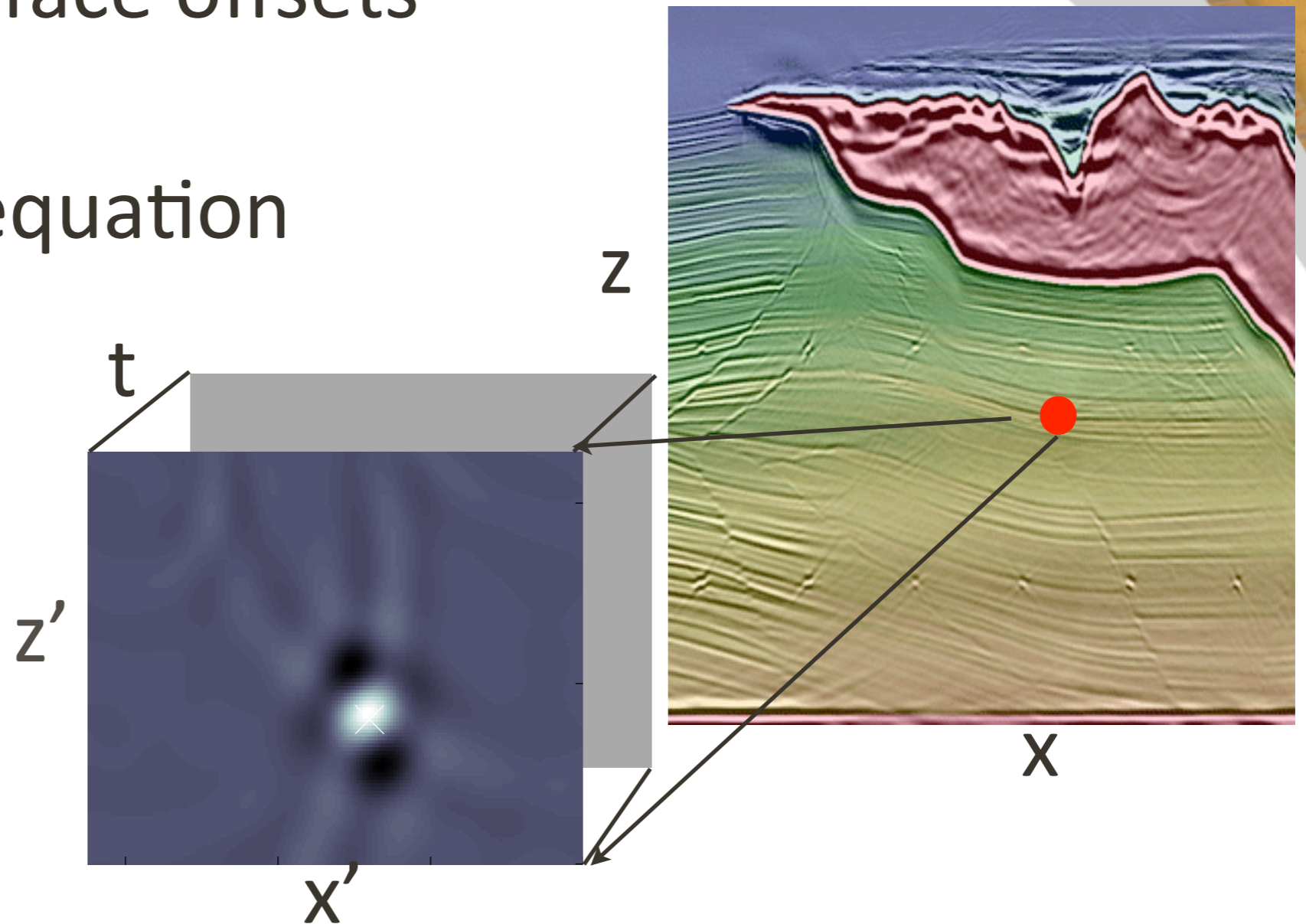
horizontal
offset

horizontal
+vertical
offset

all offsets

[Biondo & Symes, '04 ;Sava & Vasconcelos, '11]

- use *all* subsurface offsets (5D volume)
- 2-way wave-equation



but.... we can *never* hope to *compute* or *store* such an *extended* image volume!

Can we work with the *extended* volume *implicitly* ?

Overview

- Anatomy
- Physics
- Computation
- Applications:
 - 1.AVA
 - 2.MVA
- Conclusions

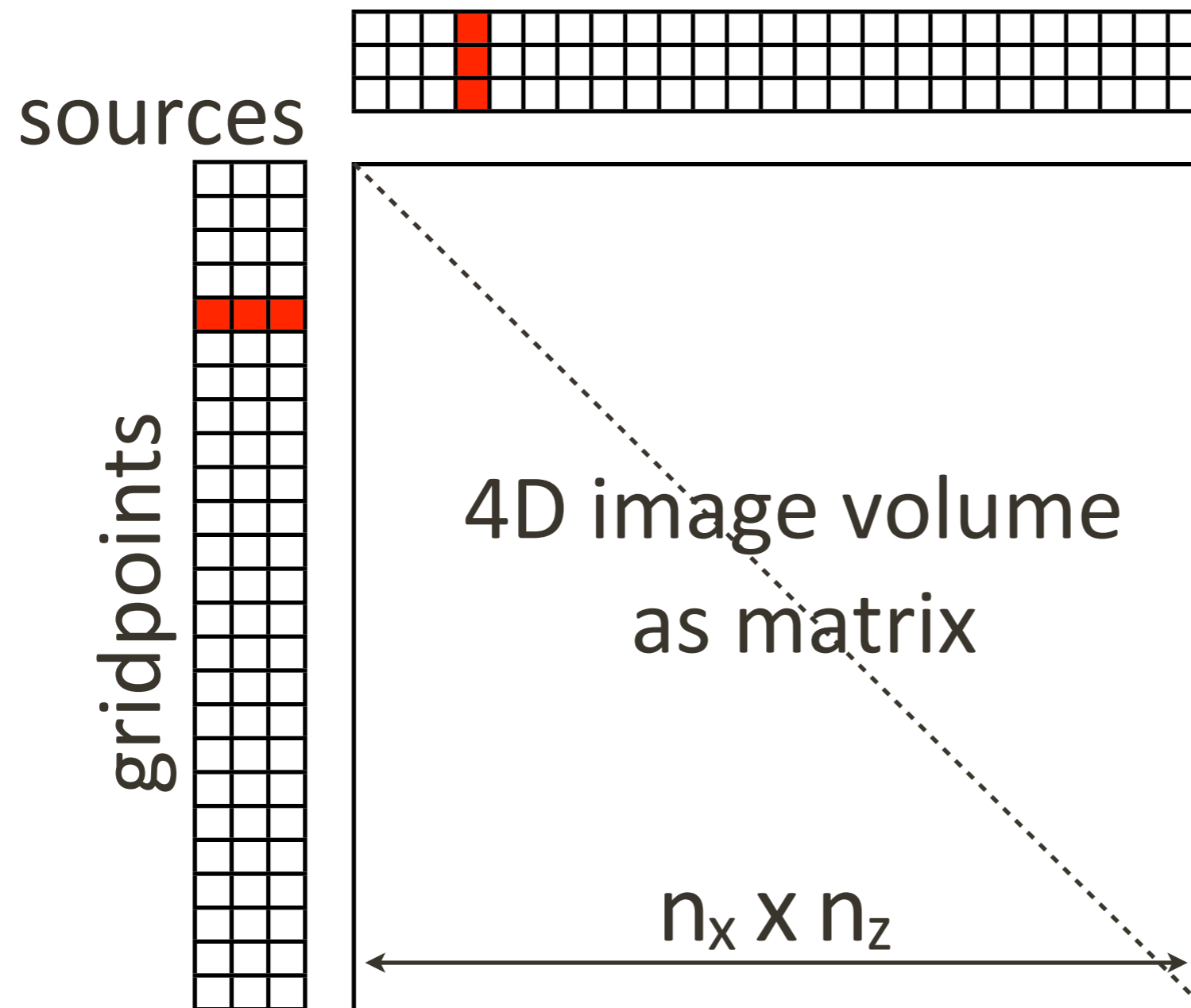
Anatomy

$$e(\omega, \mathbf{x}, \mathbf{x}') = \sum_i u_i(\omega, \mathbf{x}) v_i(\omega, \mathbf{x}')^*$$

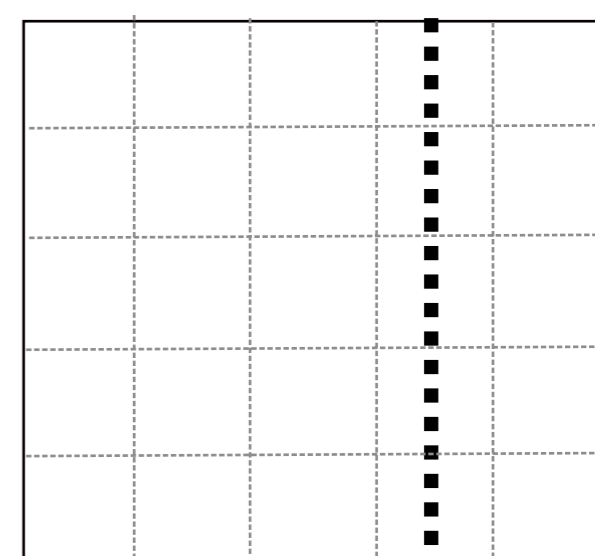
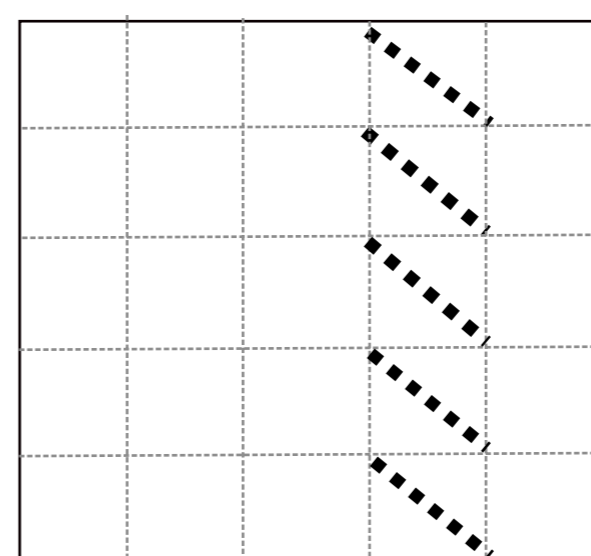
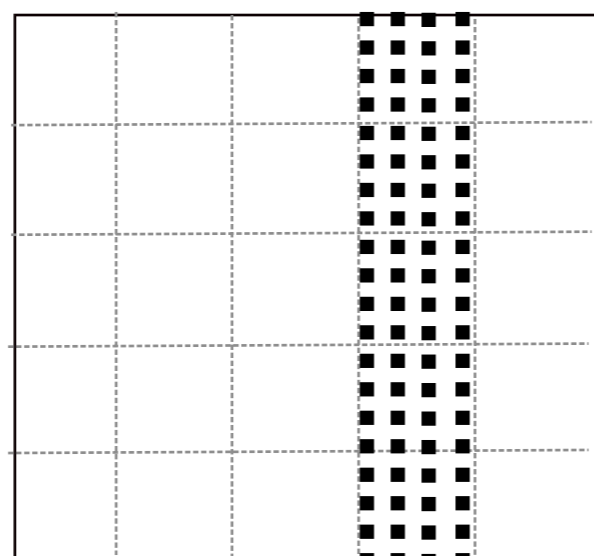
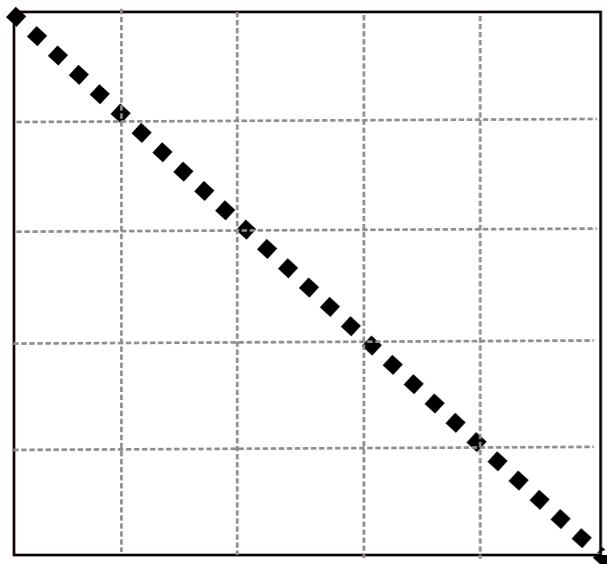
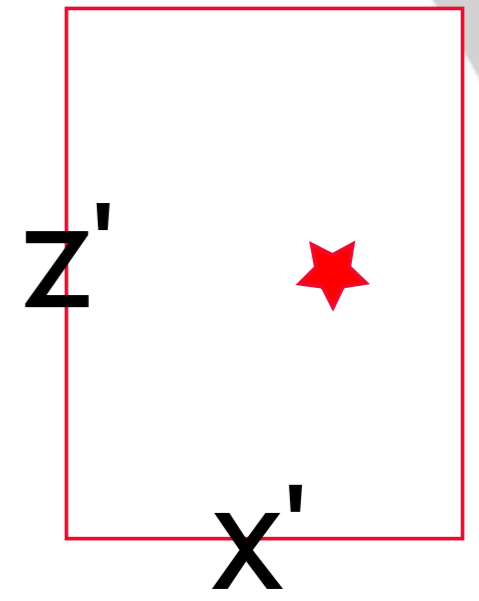
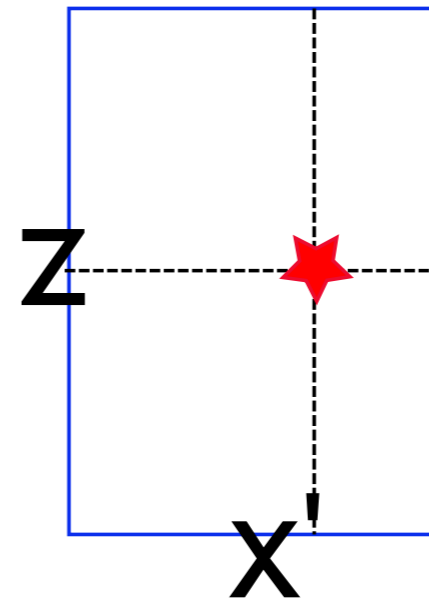
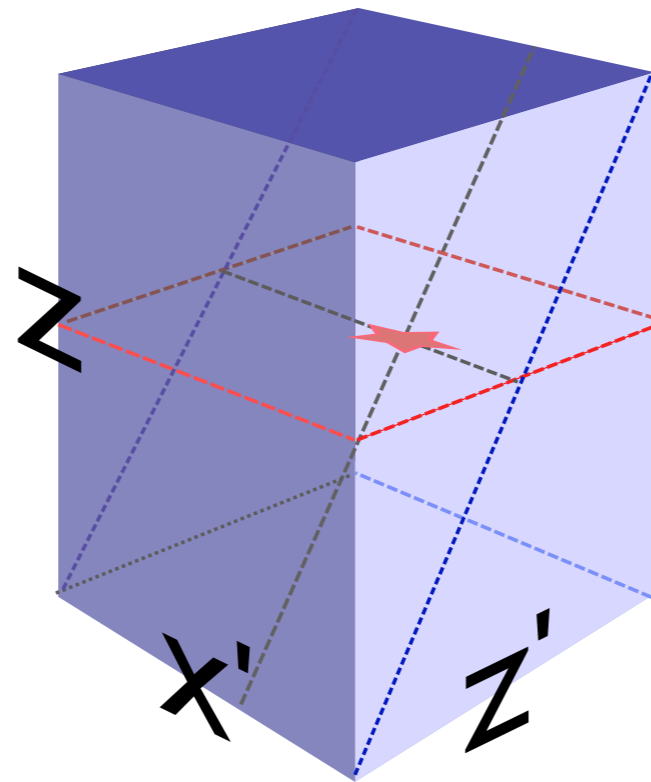
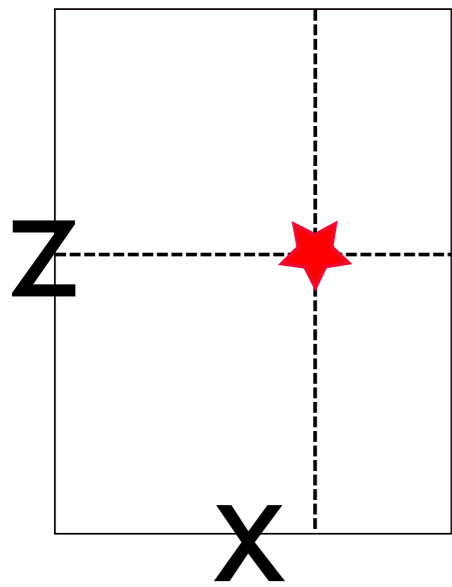
- Organize wavefields in monochromatic *data matrices*
- *Express* image volume *tensor* as *matrix*

$$E = UV^*$$

Extended images

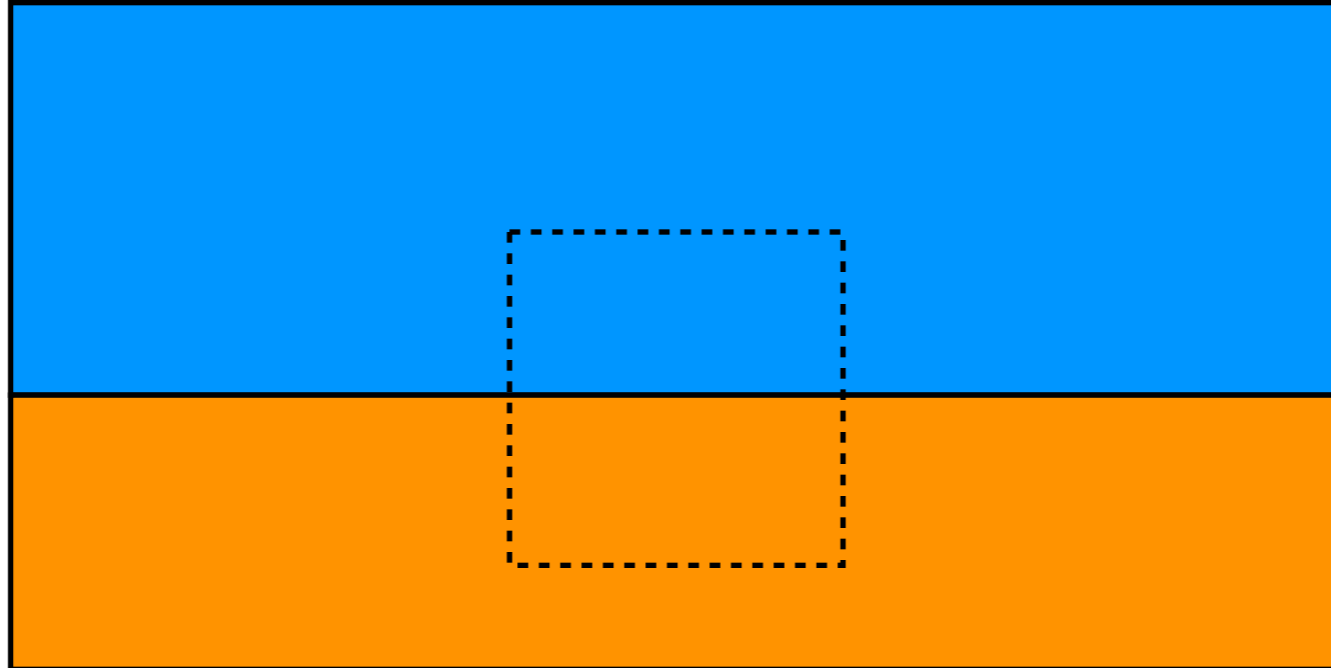


Extended images



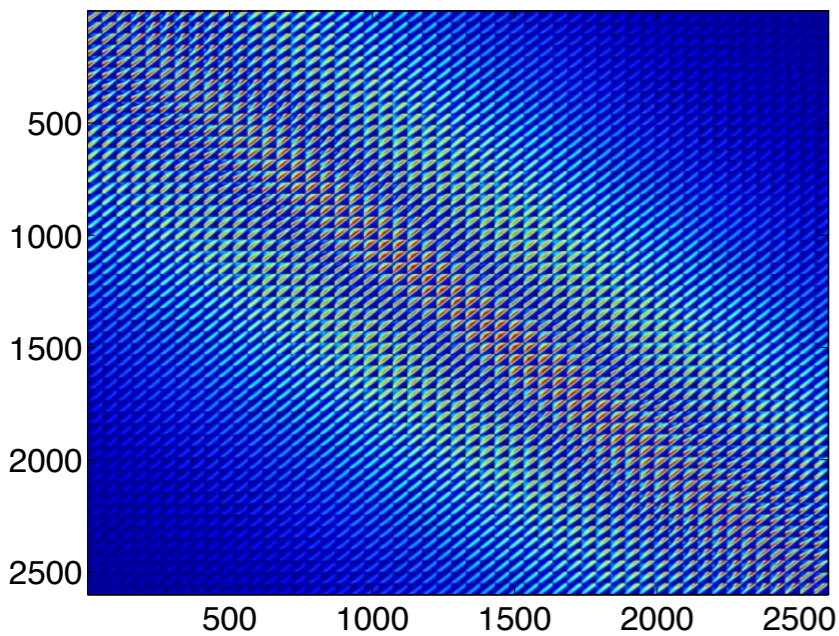
Extended images

example for *one* layer

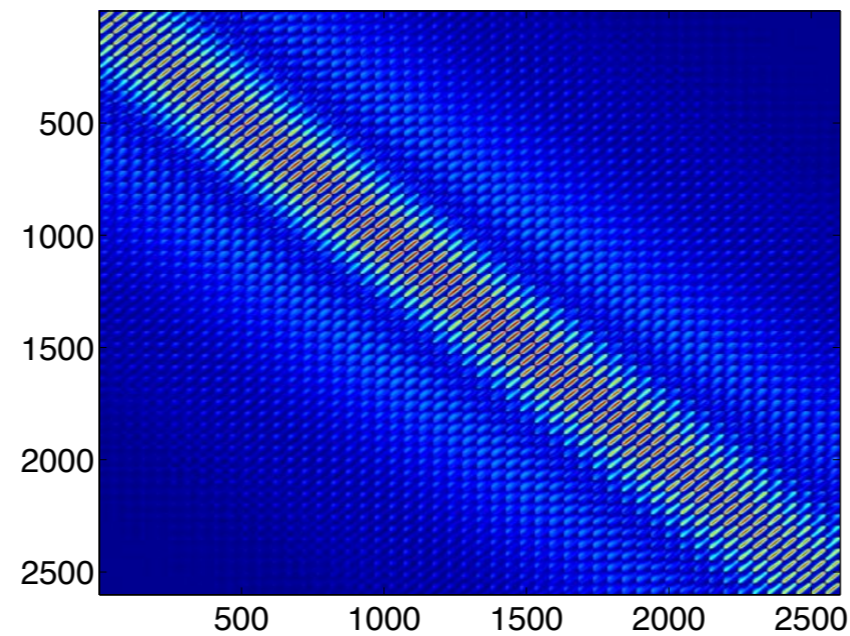


Extended images

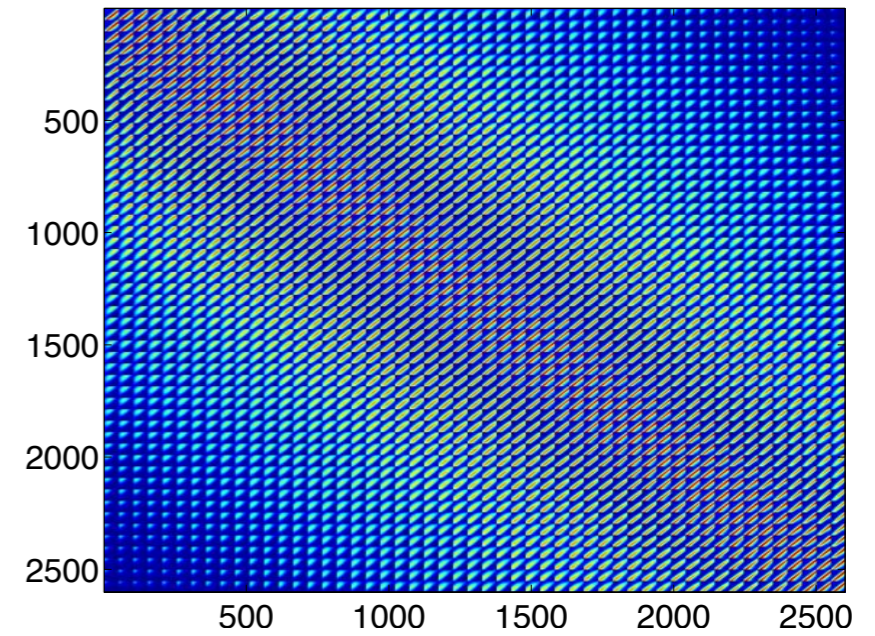
full matrix



low
velocity



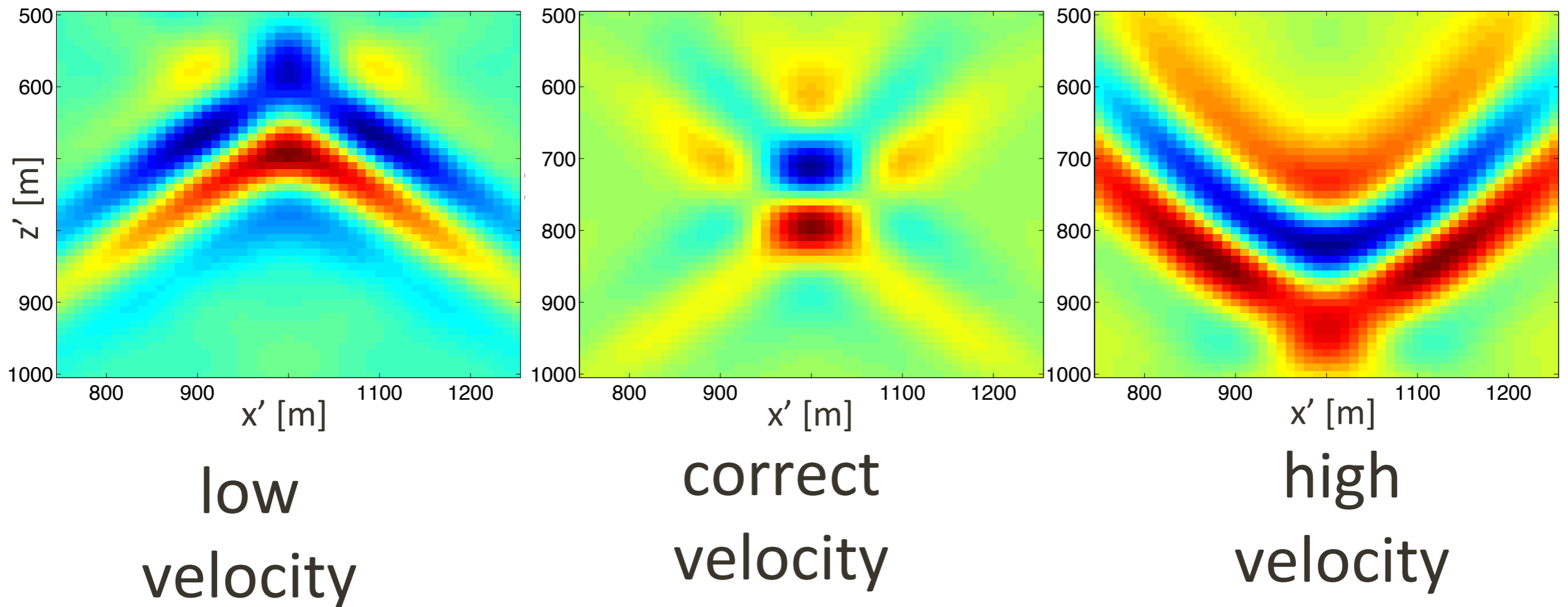
correct
velocity



high
velocity

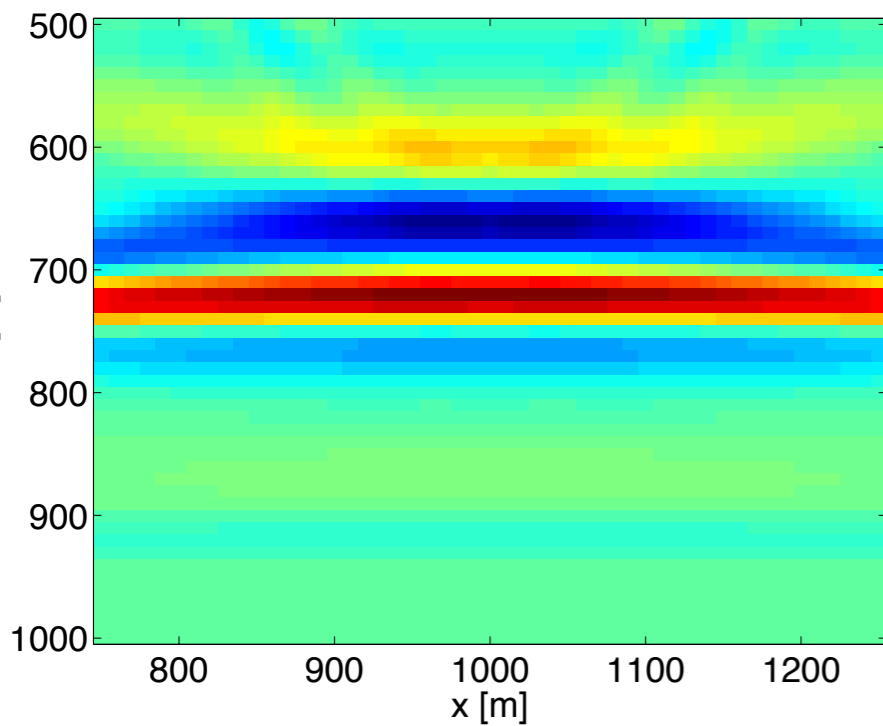
Extended images

one column

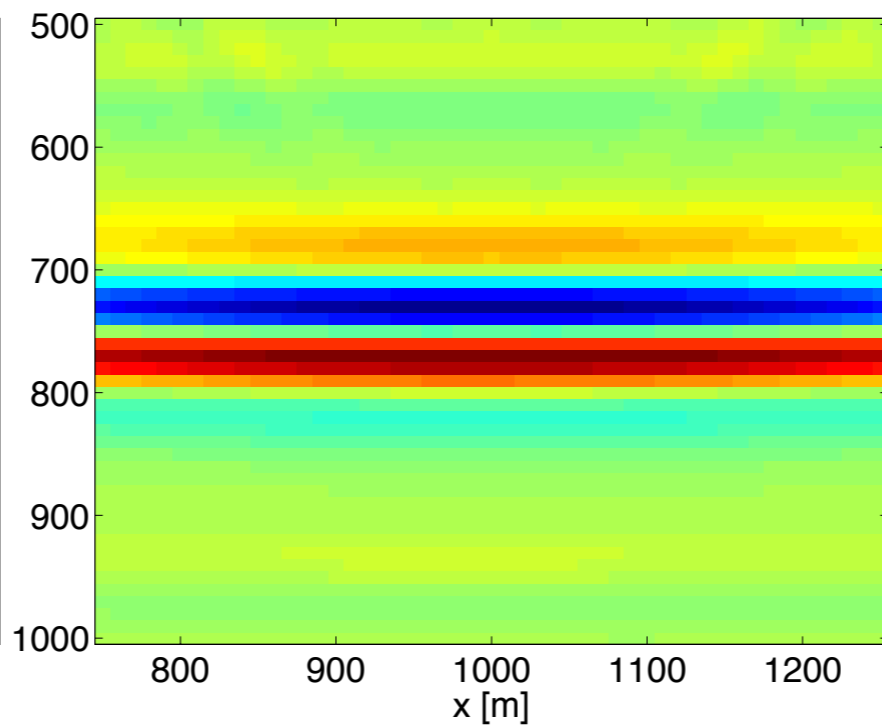


Extended images

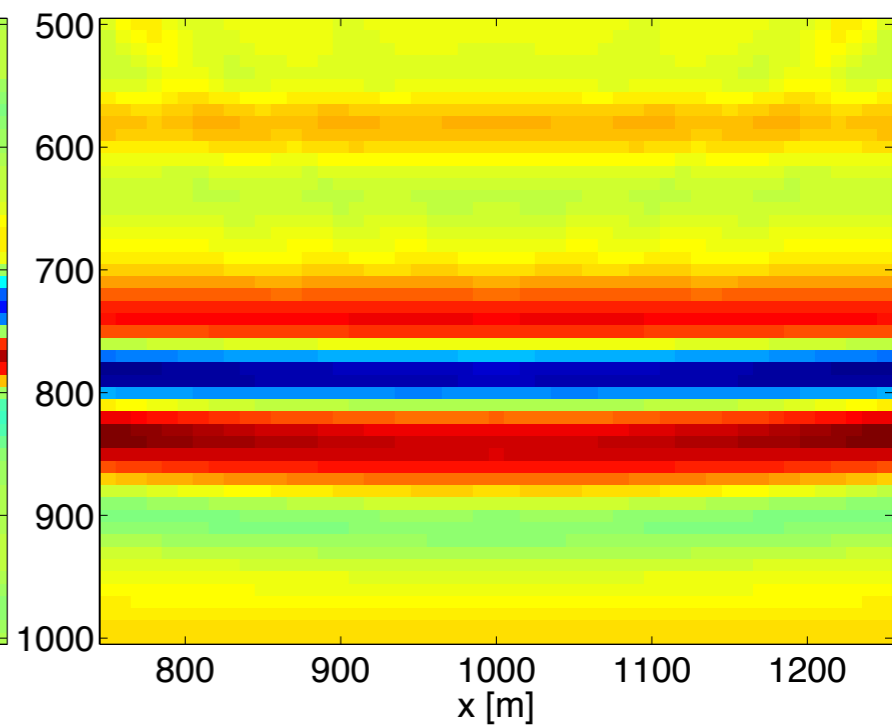
diagonal



low
velocity



correct
velocity



high
velocity

Double wave-equation

Helmholtz operator: $H = \omega^2 \text{diag}(\mathbf{m}) + \nabla^2$

source/receiver wavefields:

$$HU = P_s^T Q \quad H^*V = P_r^T D$$

RTM extended image: $E = UV^$*

yields: $HEH = P_s^T QD^ P_r$*

Double wave-equation

$$Le(\omega, \mathbf{x}, \mathbf{x}') = \int d\mathbf{s} \int d\mathbf{r} d(\omega, \mathbf{s}, \mathbf{r}) \delta(\mathbf{x} - \mathbf{s}) \delta(\mathbf{x}' - \mathbf{r})$$

two-way:

$$L = \left[\omega^2 / c(z, x)^2 + \partial_x^2 + \partial_z^2 \right] \left[\omega^2 / c(z', x')^2 + \partial_{x'}^2 + \partial_{z'}^2 \right]$$

one-way (DSR):

$$L = \left[\partial_z - i \sqrt{\omega^2 / c(z, x)^2 + \partial_x^2} - i \sqrt{\omega^2 / c(z, x')^2 + \partial_{x'}^2} \right]$$

Computation

- *complete* image volume too *large* to form: $(n_x \times n_z)^2$
- instead, *probe* volume for information via *mat-vecs* $E\mathbf{y}$
- \mathbf{y} can be interpreted as subsurface (sim.) *source* function

Computation

mat-vec with extended image:

$$\mathbf{e} = E\mathbf{y} = H^{-1}P_s^T Q D^* P_r H^{-1}\mathbf{y}$$

- $\tilde{\mathbf{d}} = P_r H^{-1}\mathbf{y}$ (*one subsurface source*)
- $\tilde{\mathbf{w}} = D^* \tilde{\mathbf{d}}$ (*source weights*)
- $\mathbf{e} = H^{-1}P_s^T Q \tilde{\mathbf{w}}$ (*one source*)

Computation

Are able to compute *full*-subsurface image gathers

- ▶ *w/o looping over all sources*
- ▶ derives from *reciprocity* principle
- ▶ probe image space w/ arbitrary *test functions*
 - *point scatterers* (one at location of subsurface point)
 - Gaussian weights (*simultaneous source*)

Computation

computation of an *image point gather*

	# of PDE solves	“flops for correlations”
conventional	$2N_s$	$N_s \times N_h$
mat-vecs	2	$N_s \times N_r$

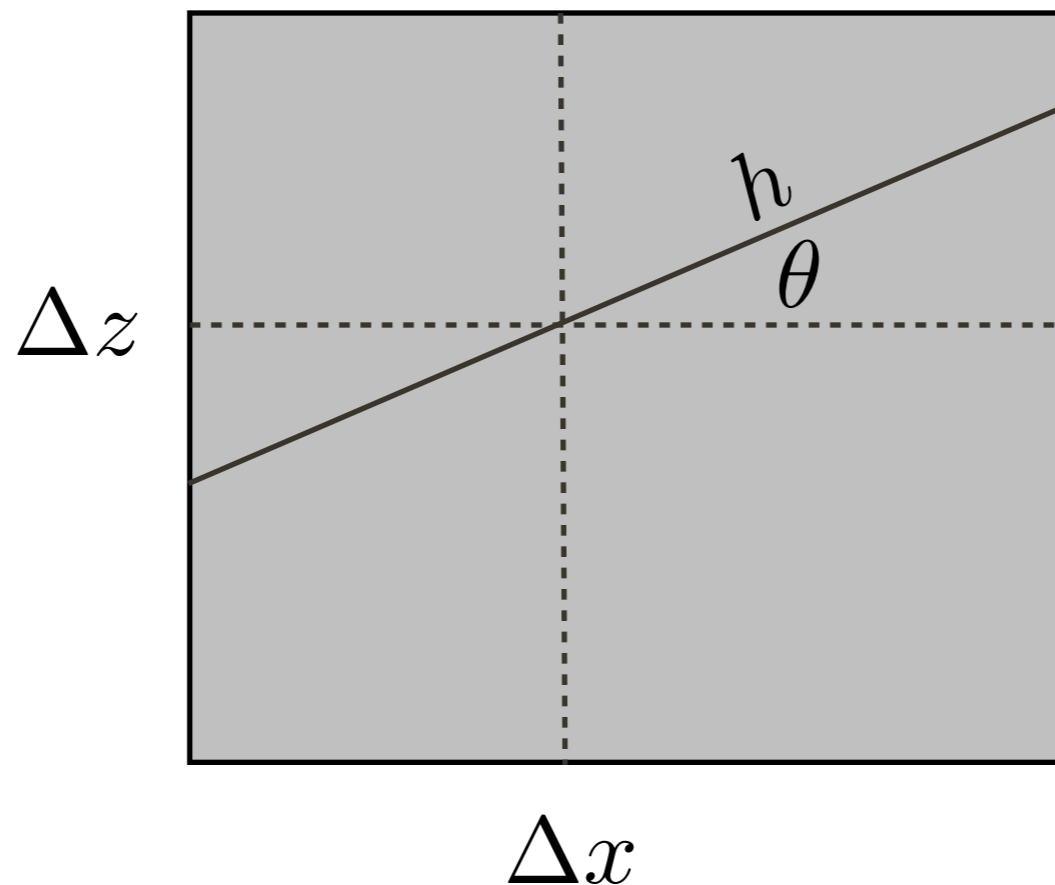
N_s - # of sources

N_r - # of receivers

N_h - # of subsurface offsets

Dip-angle gathers

align subsurface offset with local dip

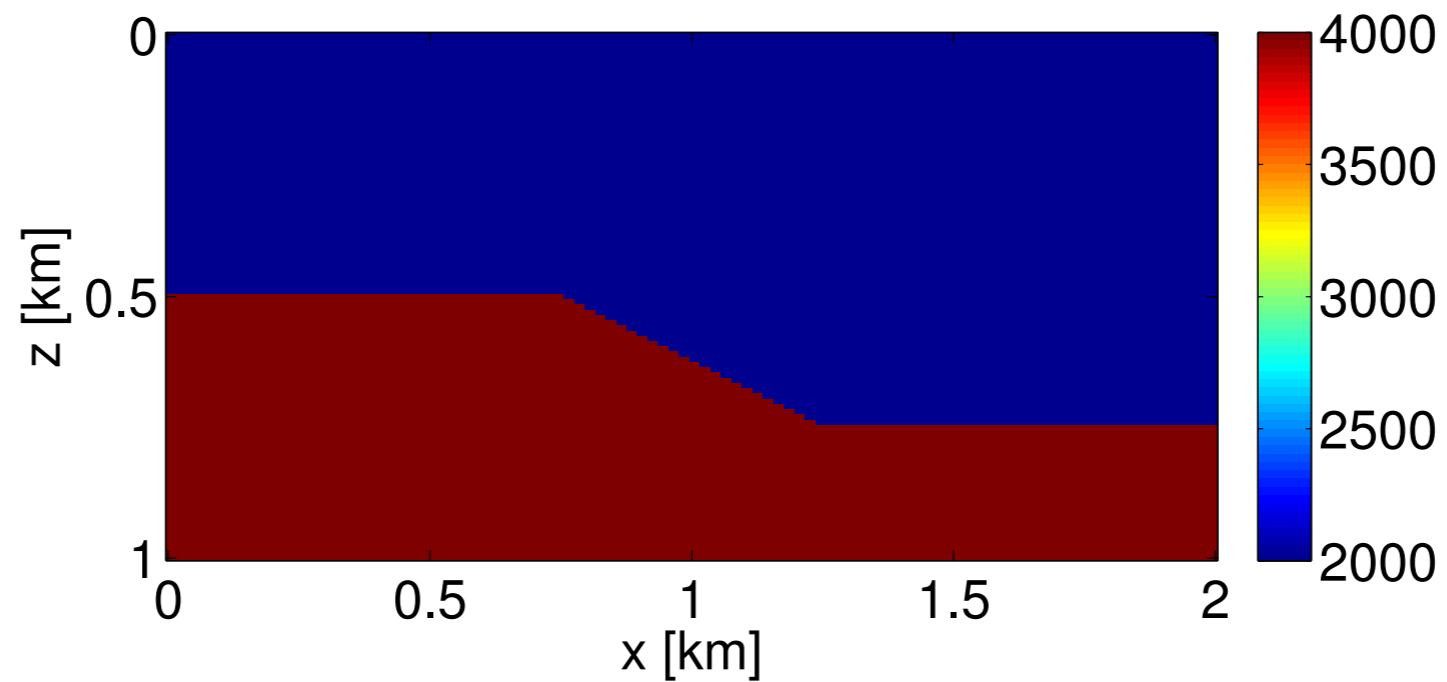


Dip-angle gathers

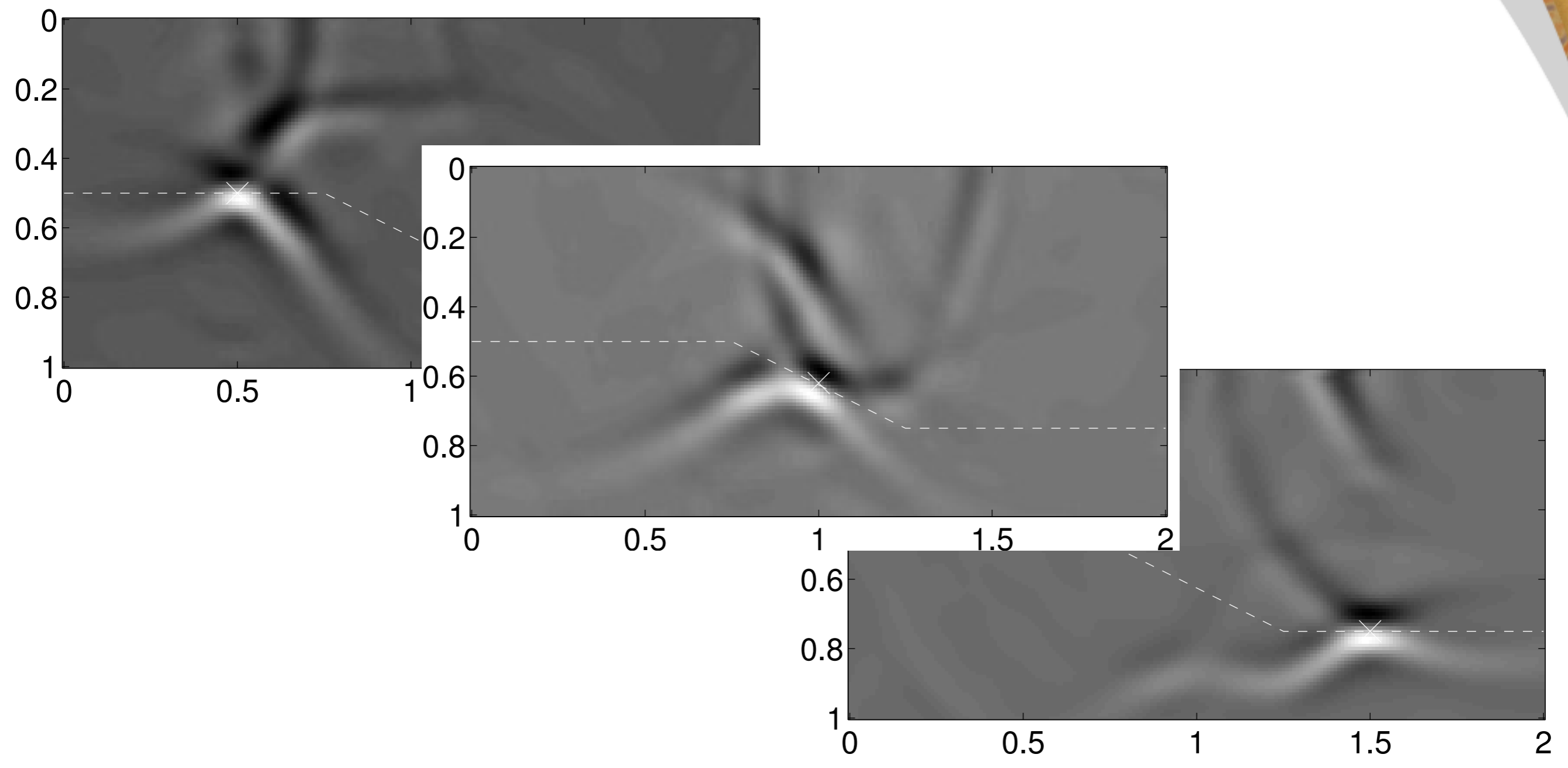
1. compute *image*-point gather
2. determine dip
3. extract *offset* along *dip*
4. *Radon* transform to compute *angle* gather

Dip-angle gathers

example

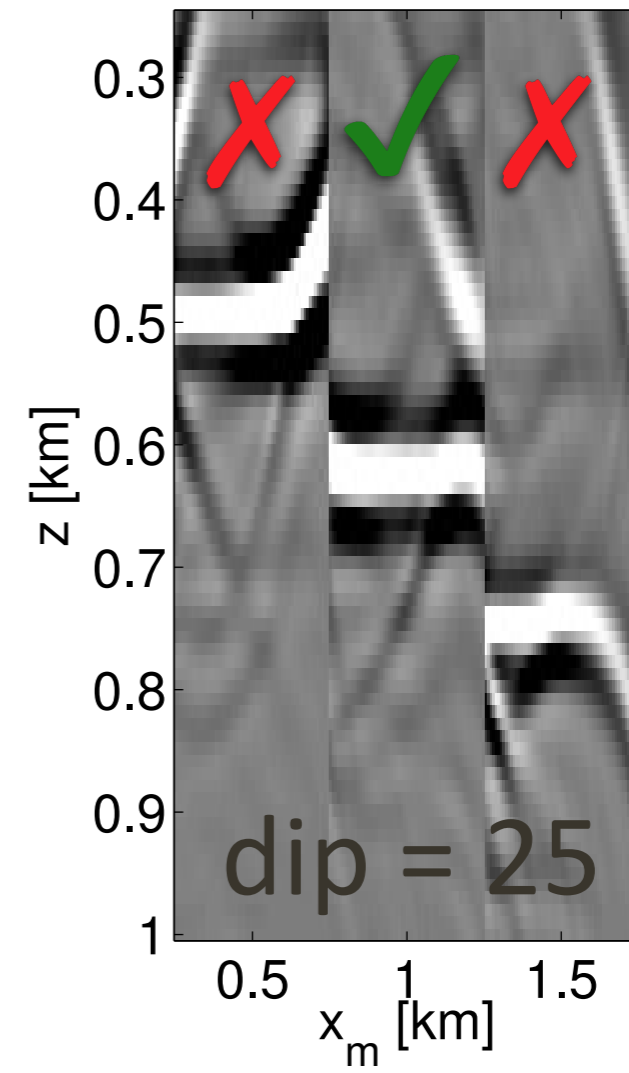
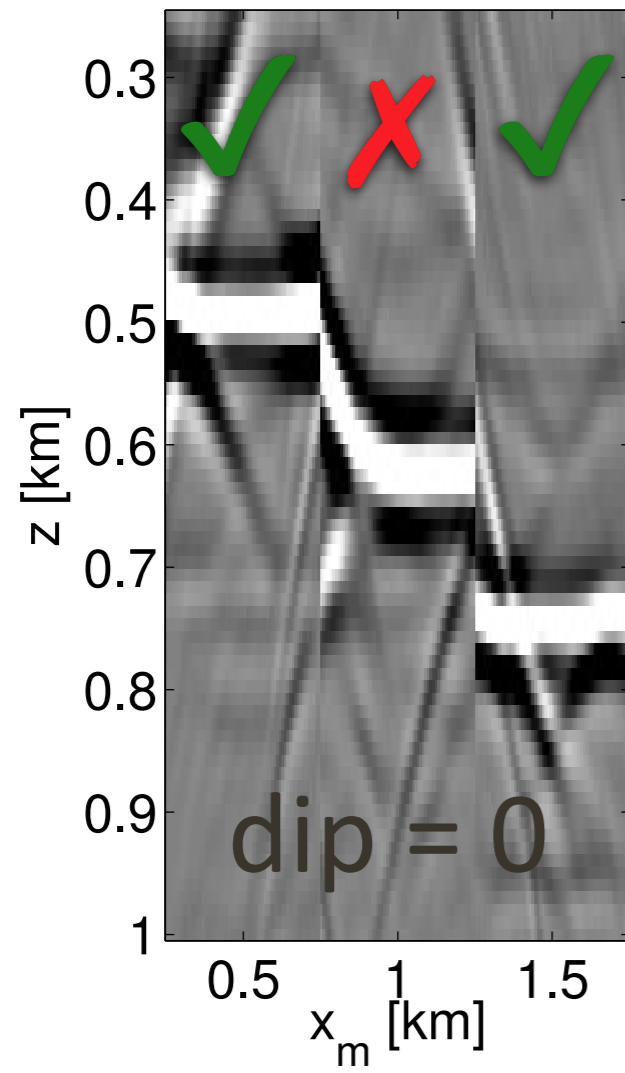


Dip-angle gathers



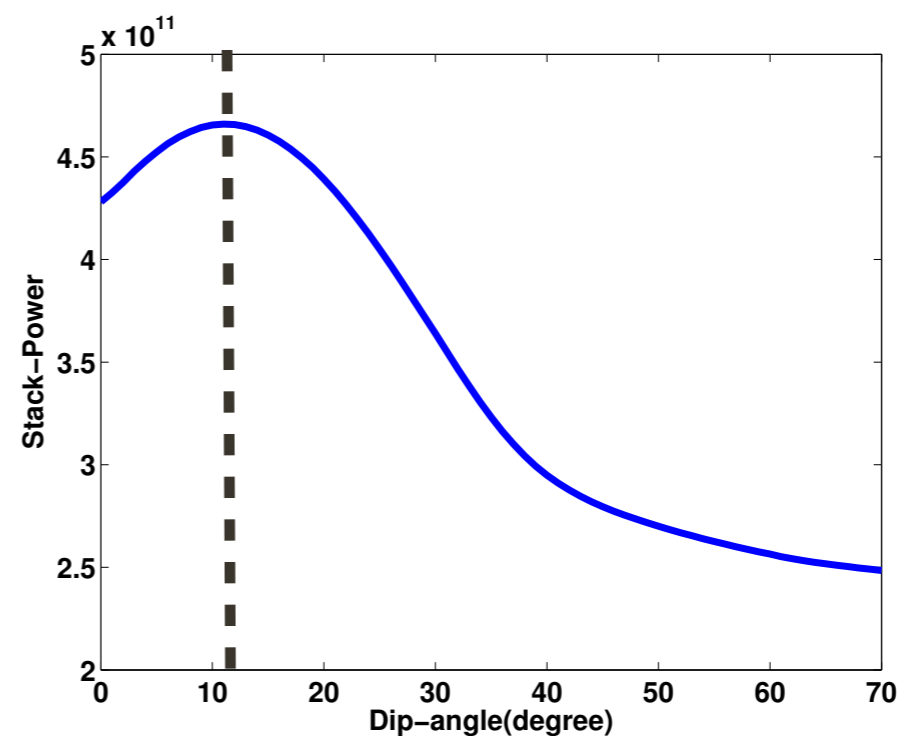
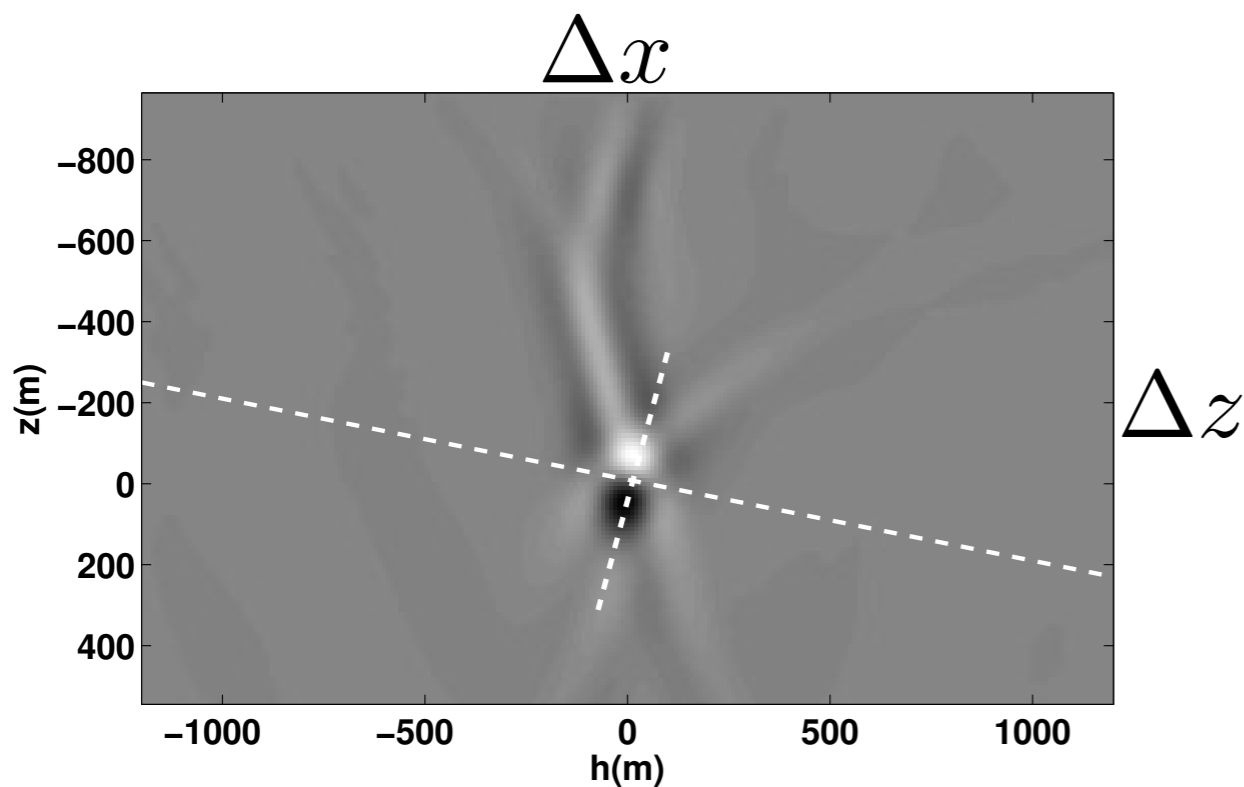
Dip-angle gathers

angle gathers for *correct* velocity, should all be *flat*



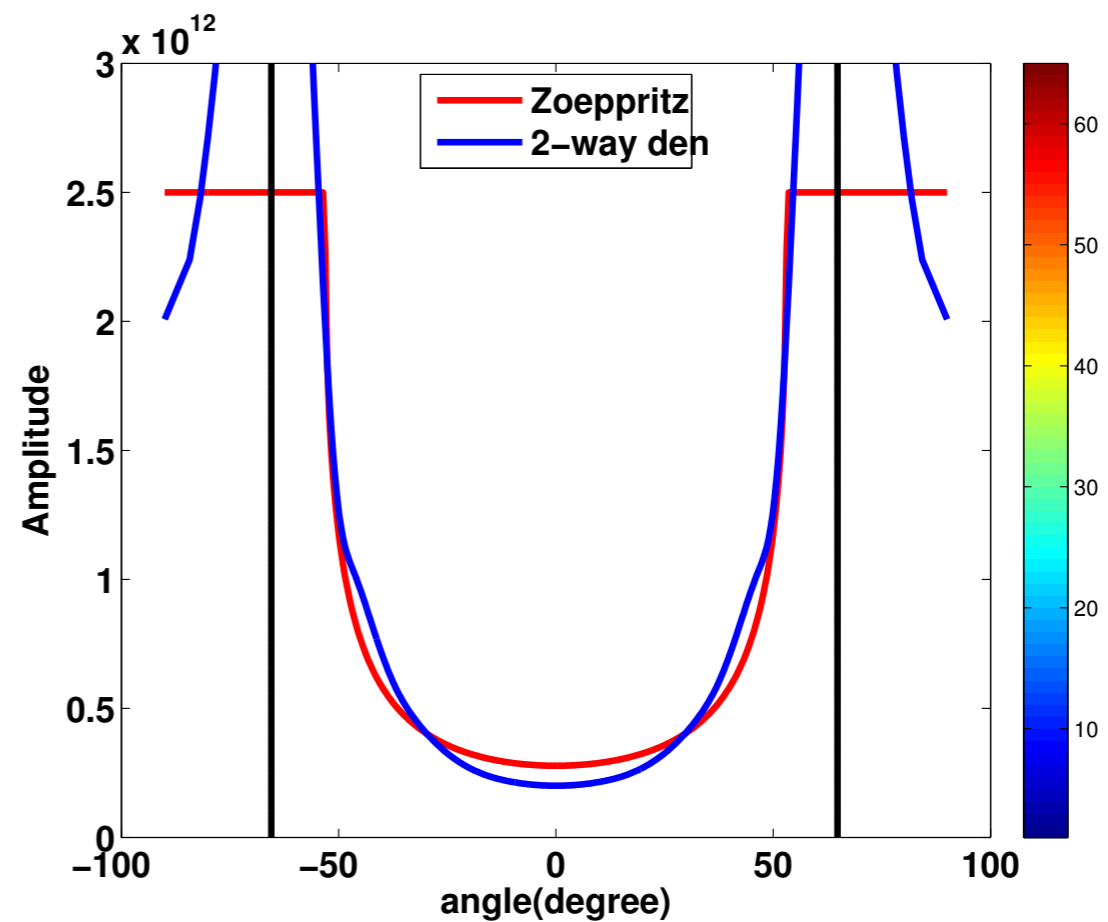
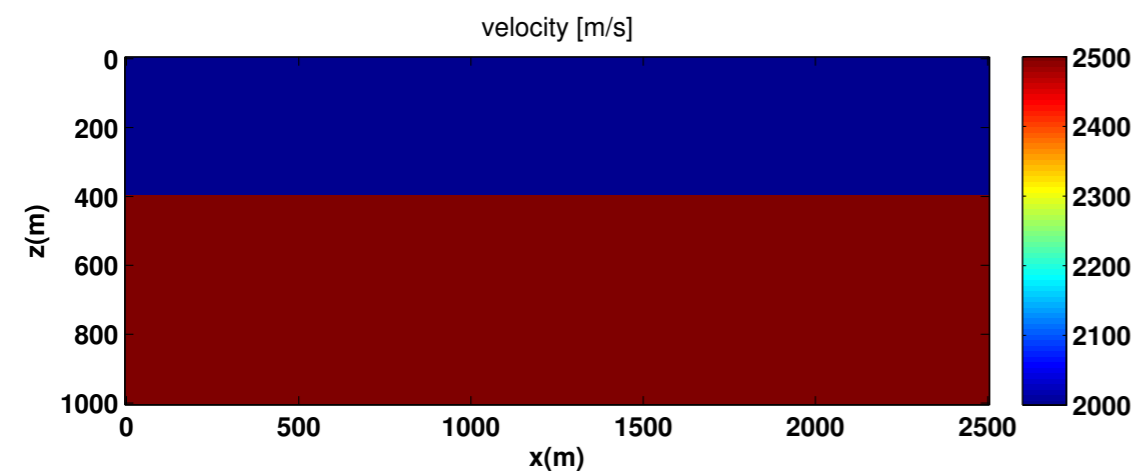
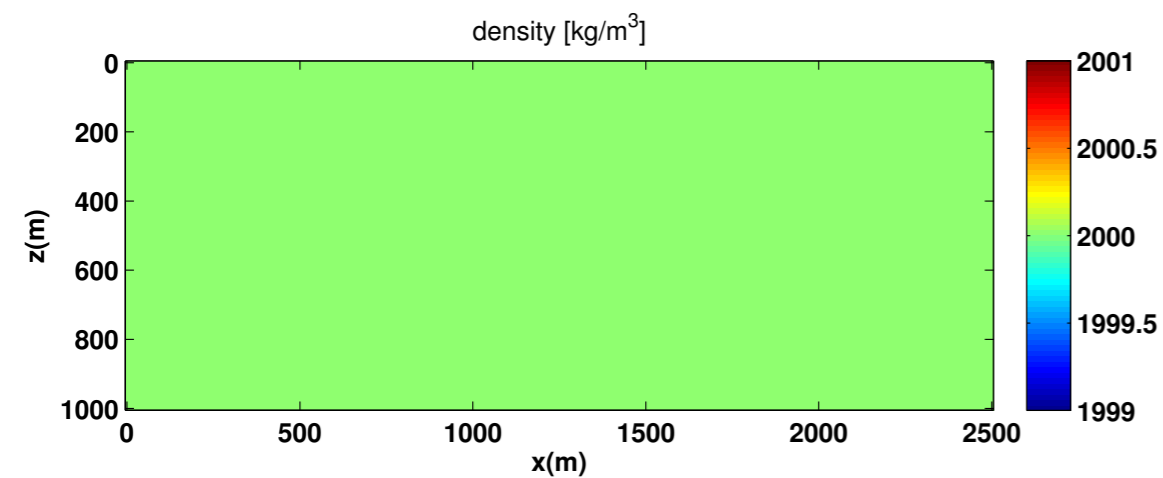
Dip-angle gathers

the *dip* can be *detected* by measuring the *stackpower* normal to the *dip*

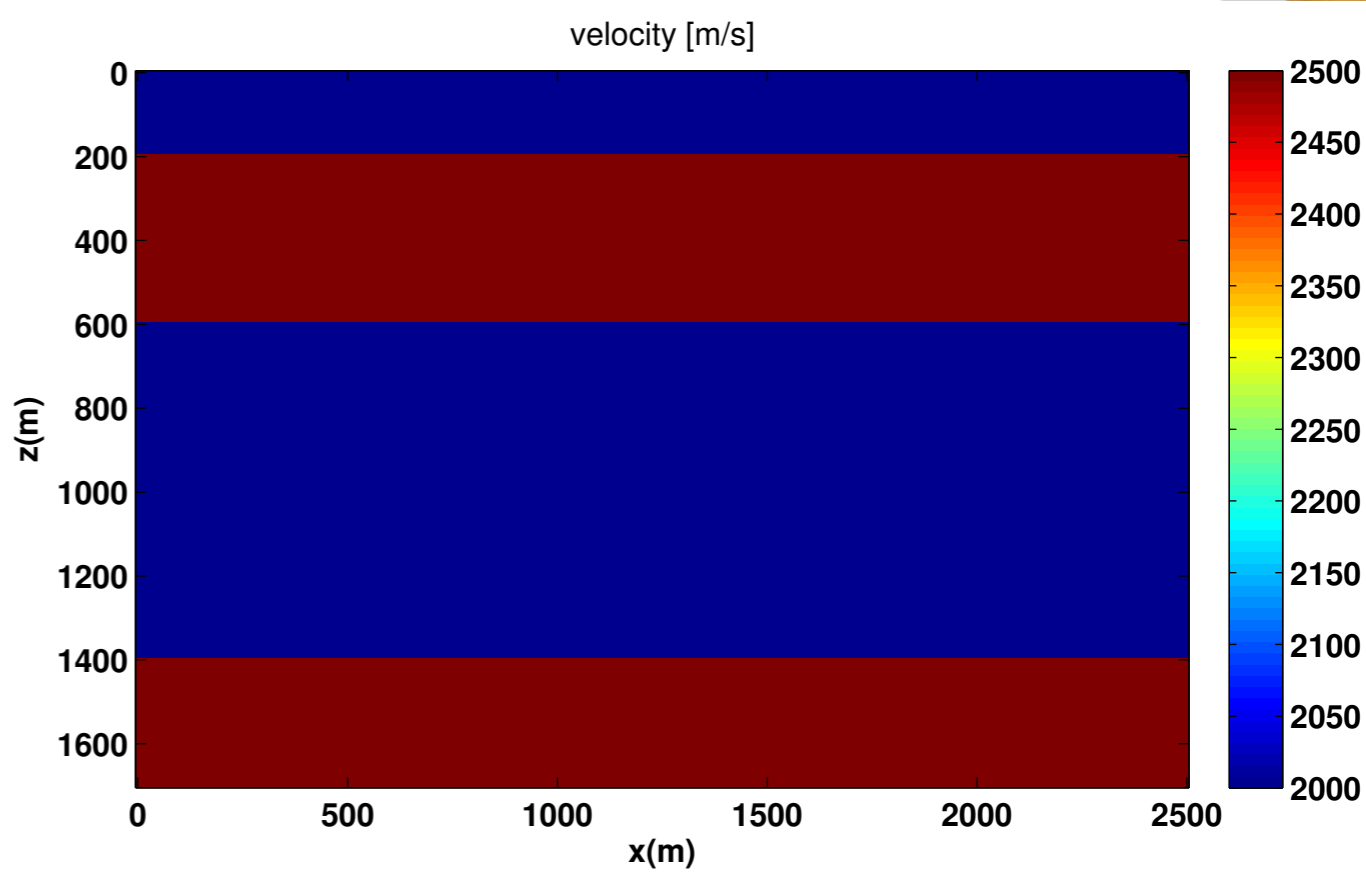
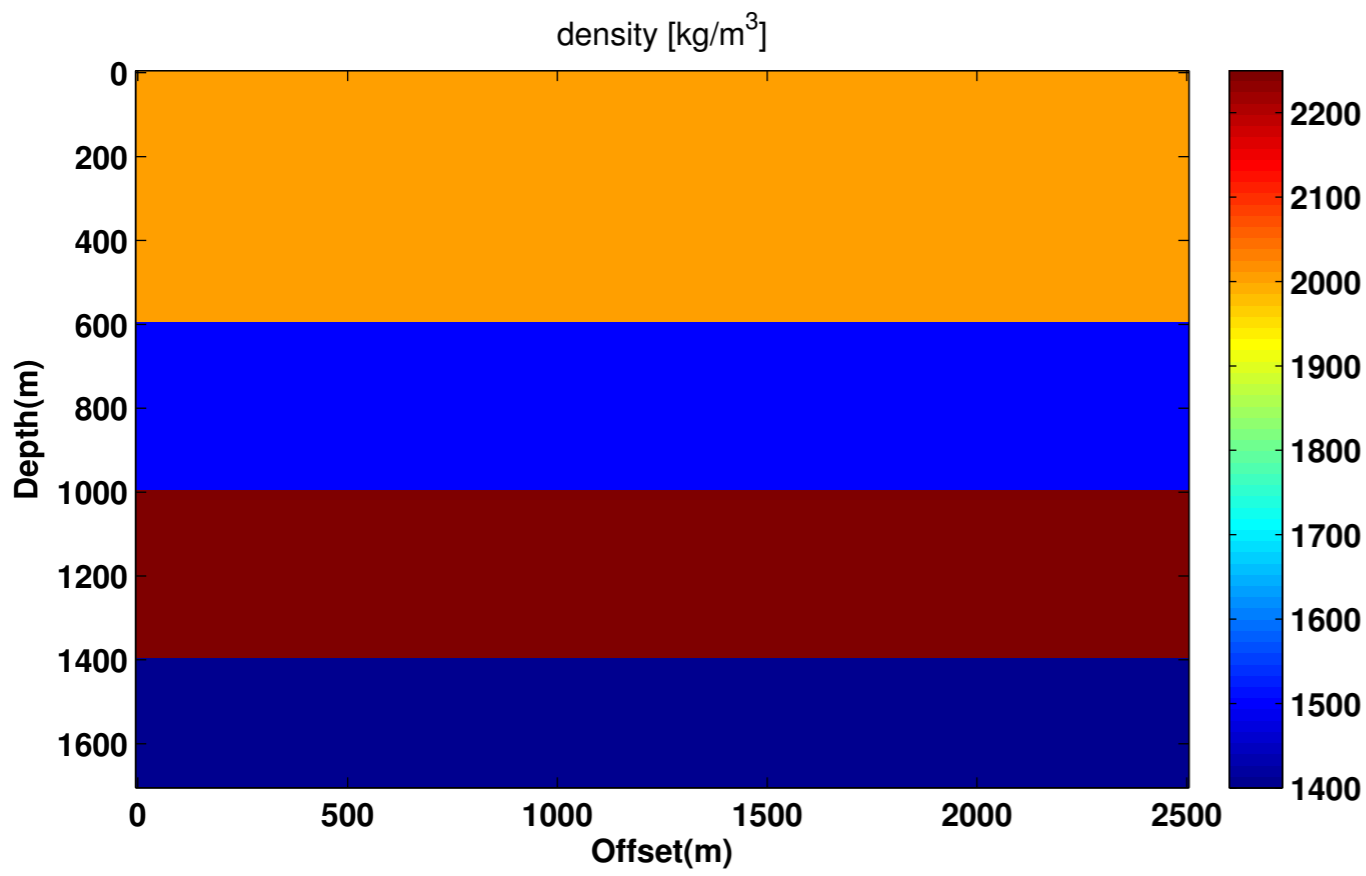


AVA

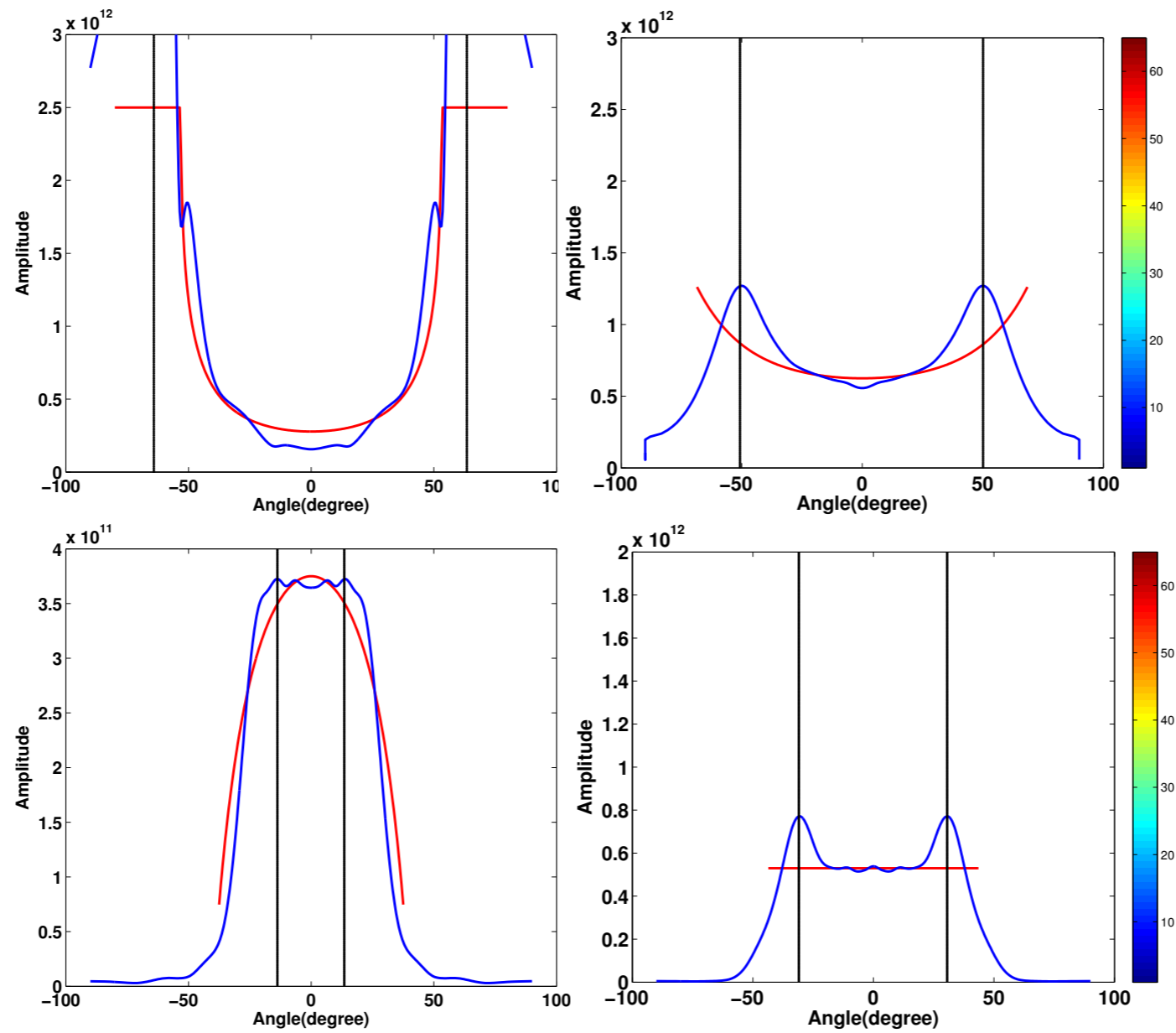
amplitude behavior of *angle* gathers can be used for *AVA*



AVA



AVA



MVA

Focusing in Δx implies a *commutation* relation: $x \cdot f(x, x') = x' \cdot f(x, x')$

or

$$E \text{diag}(\mathbf{x}) = \text{diag}(\mathbf{x}) E$$

Measure the error in some norm

$$\|E \text{diag}(\mathbf{x}) - \text{diag}(\mathbf{x}) E\|_?^2$$

MVA

The *Frobenius* norm can be estimated via *randomized* trace estimation:

$$\begin{aligned} \|A\|_F^2 &= \text{trace}(A^T A) \\ &\approx \sum_{i=1}^K \mathbf{w}_i^T A^T A \mathbf{w}_i = \sum_{i=1}^K \|A \mathbf{w}_i\|_2^2 \end{aligned}$$

where $\sum_{i=1}^K \mathbf{w}_i \mathbf{w}_i^T \approx I$

MVA

objective and gradient

$$\phi(\mathbf{m}) = \sum_k \frac{1}{2} \|R(\mathbf{m})\mathbf{w}_k\|_2^2$$

$$\nabla\phi(\mathbf{m}) = \sum_k DR(\mathbf{m}, \mathbf{w}_k)^* R(\mathbf{m})$$

where

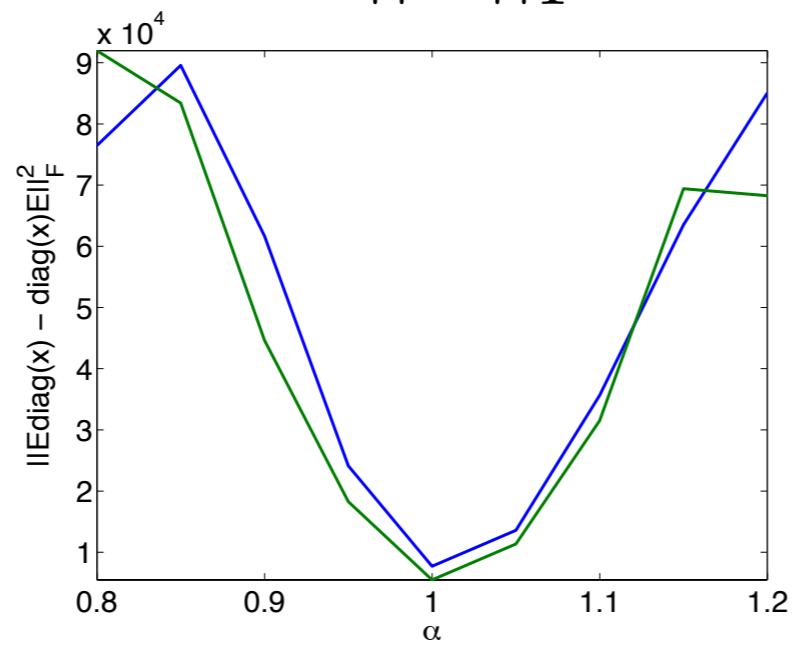
$$R(\mathbf{m}) = E(\mathbf{m})\text{diag}(\mathbf{x}) - \text{diag}(\mathbf{x})E(\mathbf{m})$$

$$DR(\mathbf{m}, \mathbf{w}) = \frac{\partial R\mathbf{w}}{\partial \mathbf{m}}$$

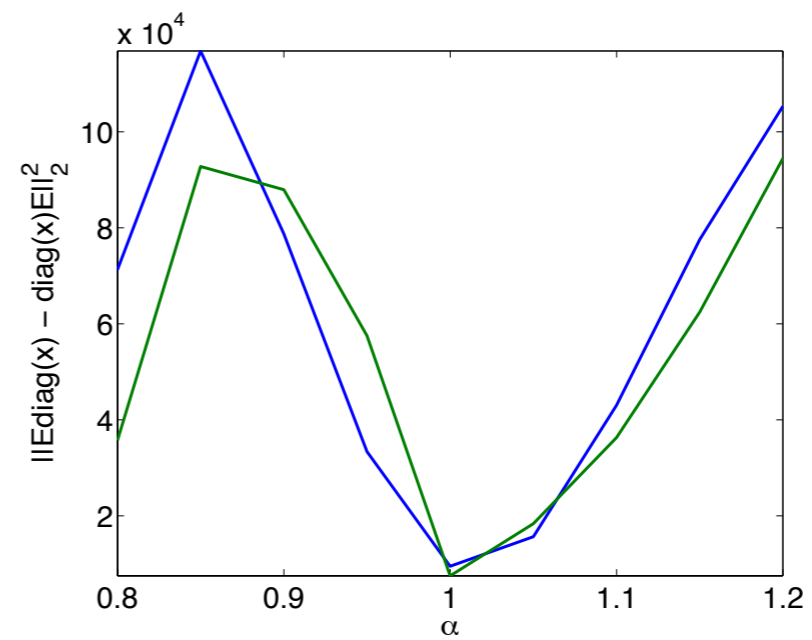
MVA

$K = 2$

$$\|\cdot\|_F^2$$

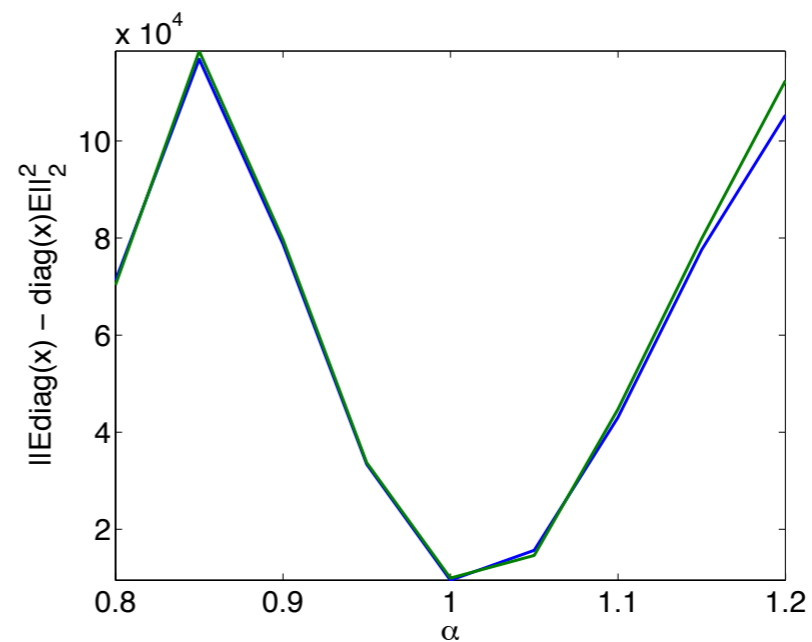
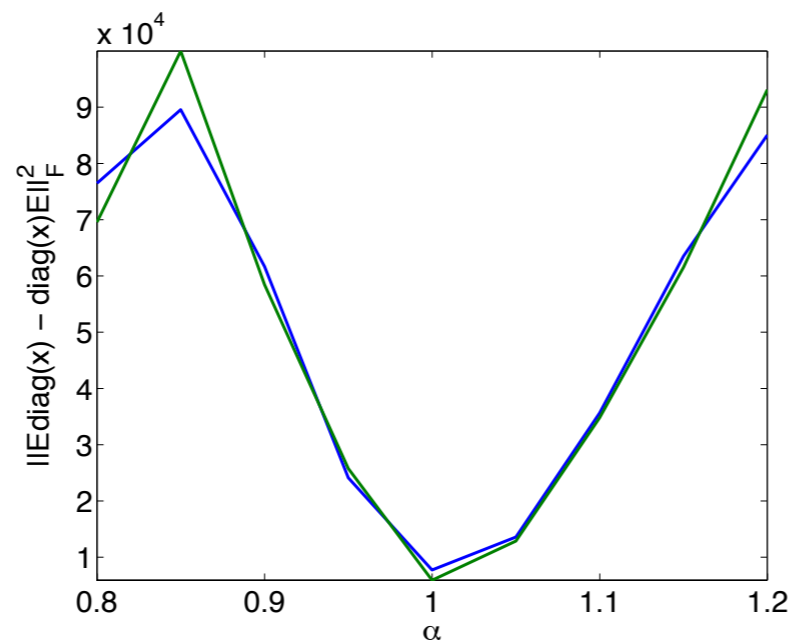


$$\|\cdot\|_2^2$$

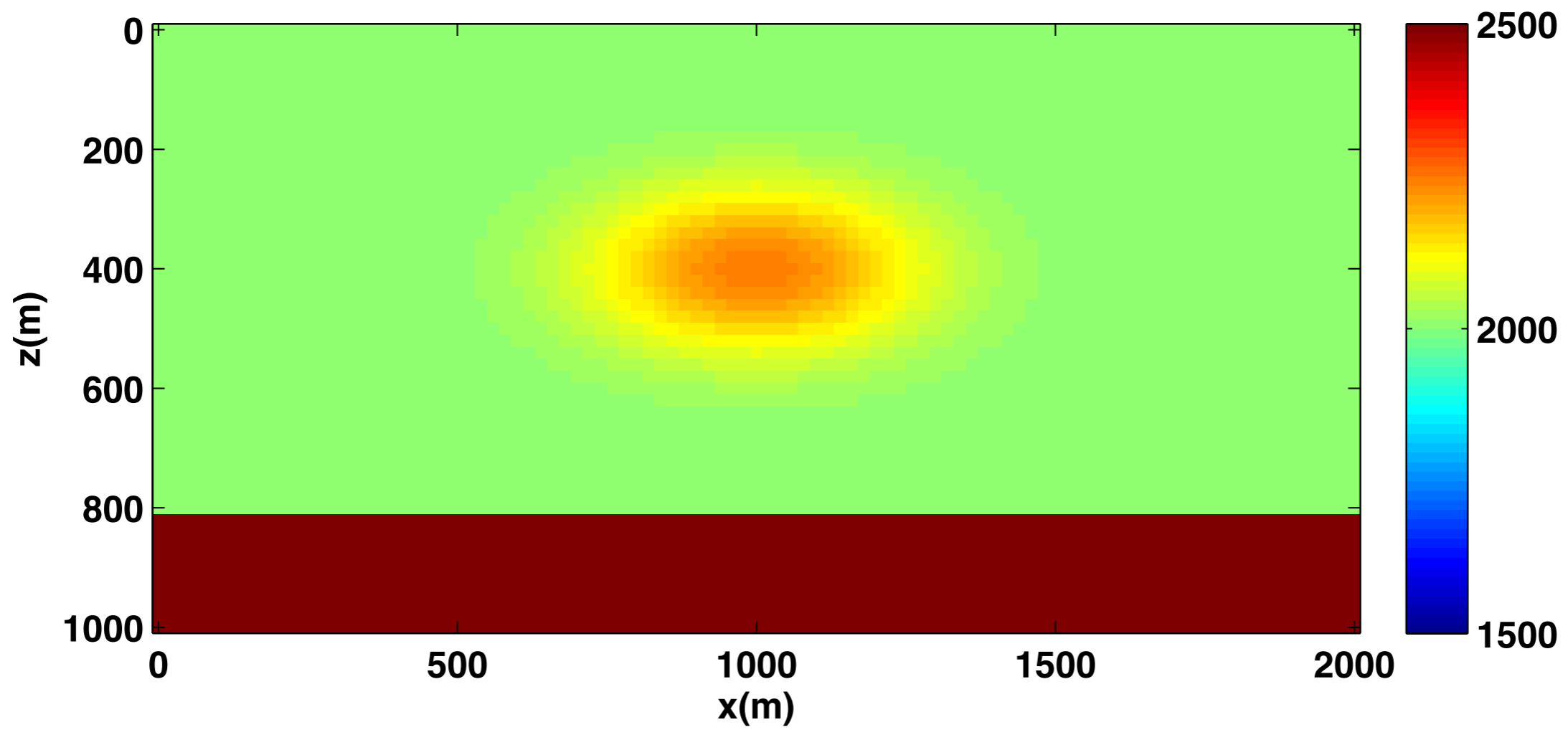


— TRUE
— ESTIMATE

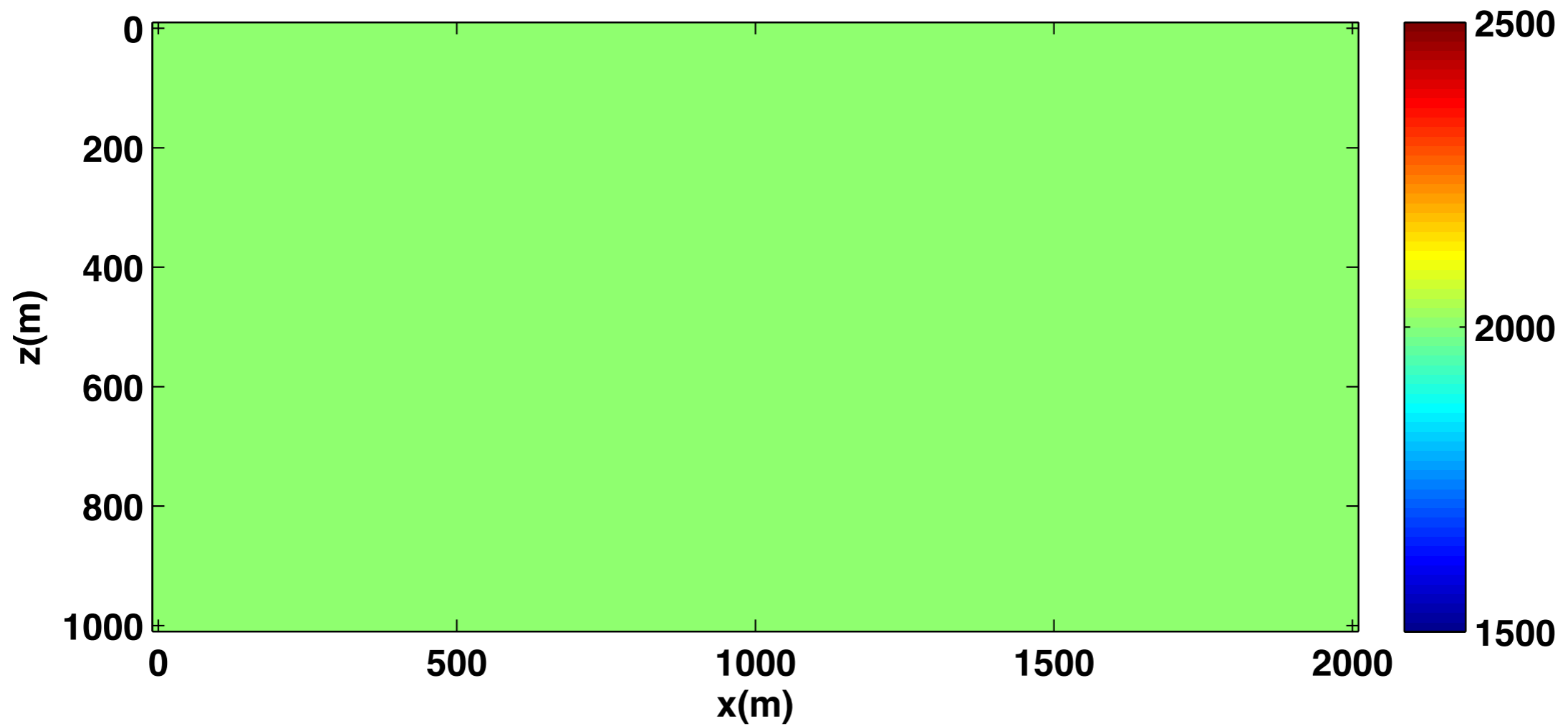
$K = 10$



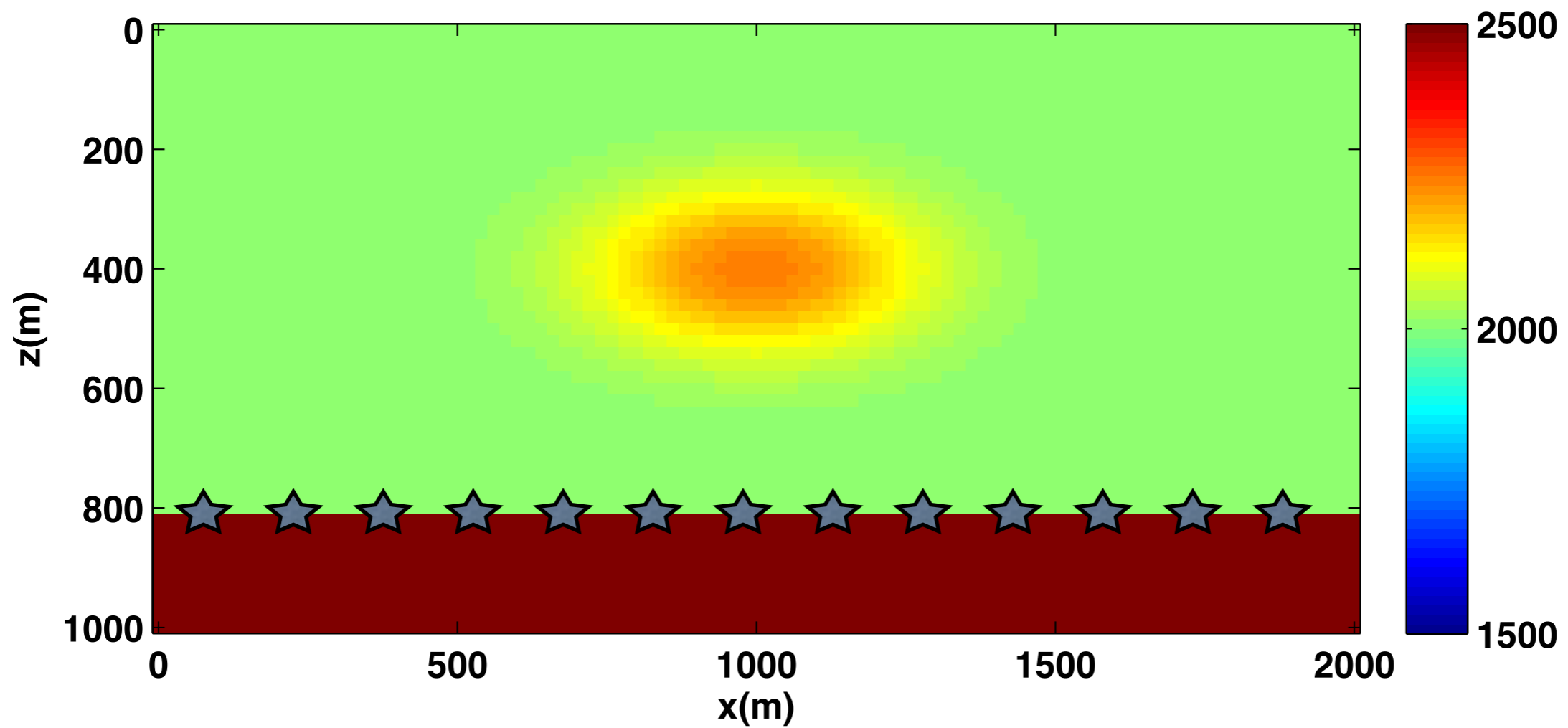
Lens Model



Initial Model

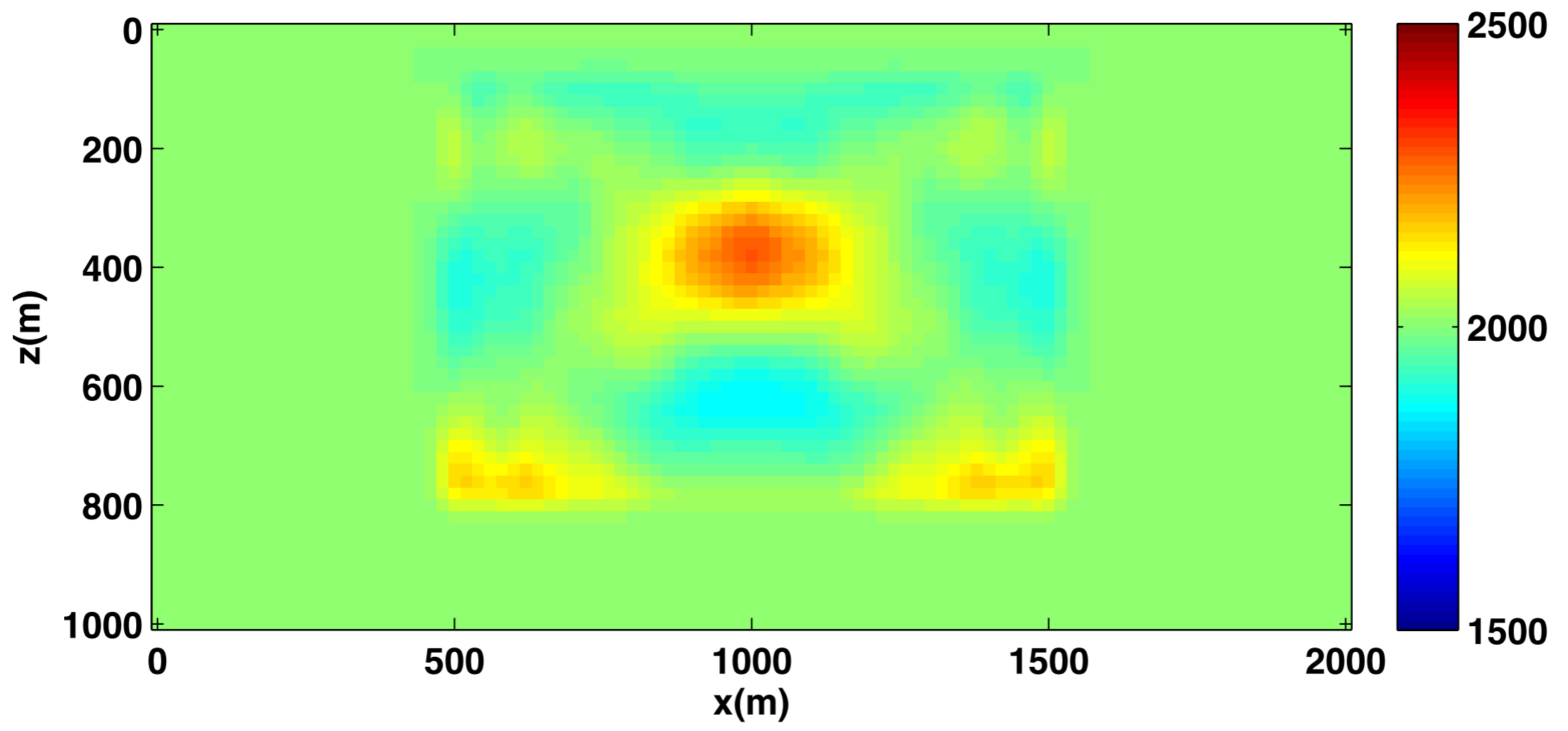


Lens Model

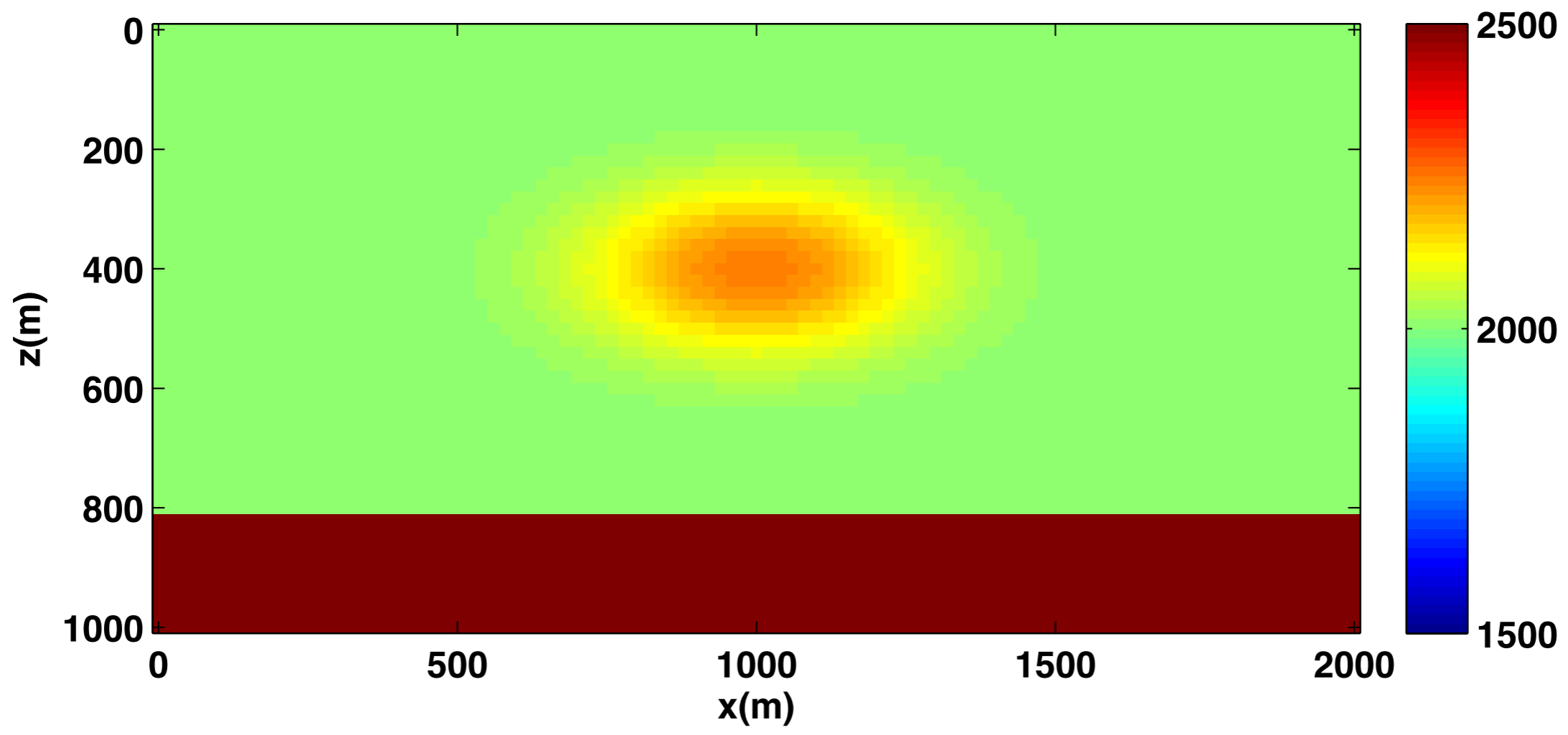


 **represents common image points**

MVA

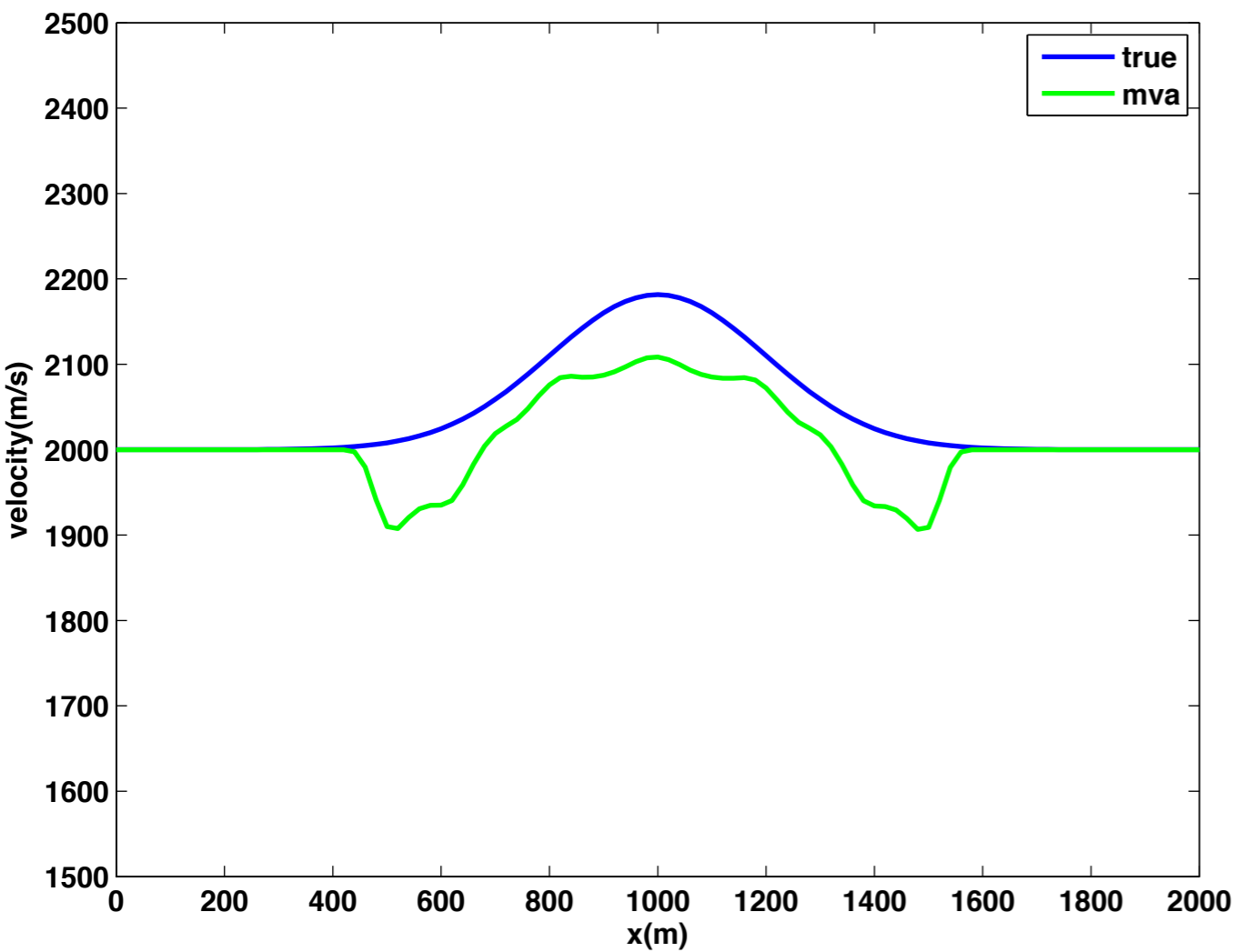


Lens Model

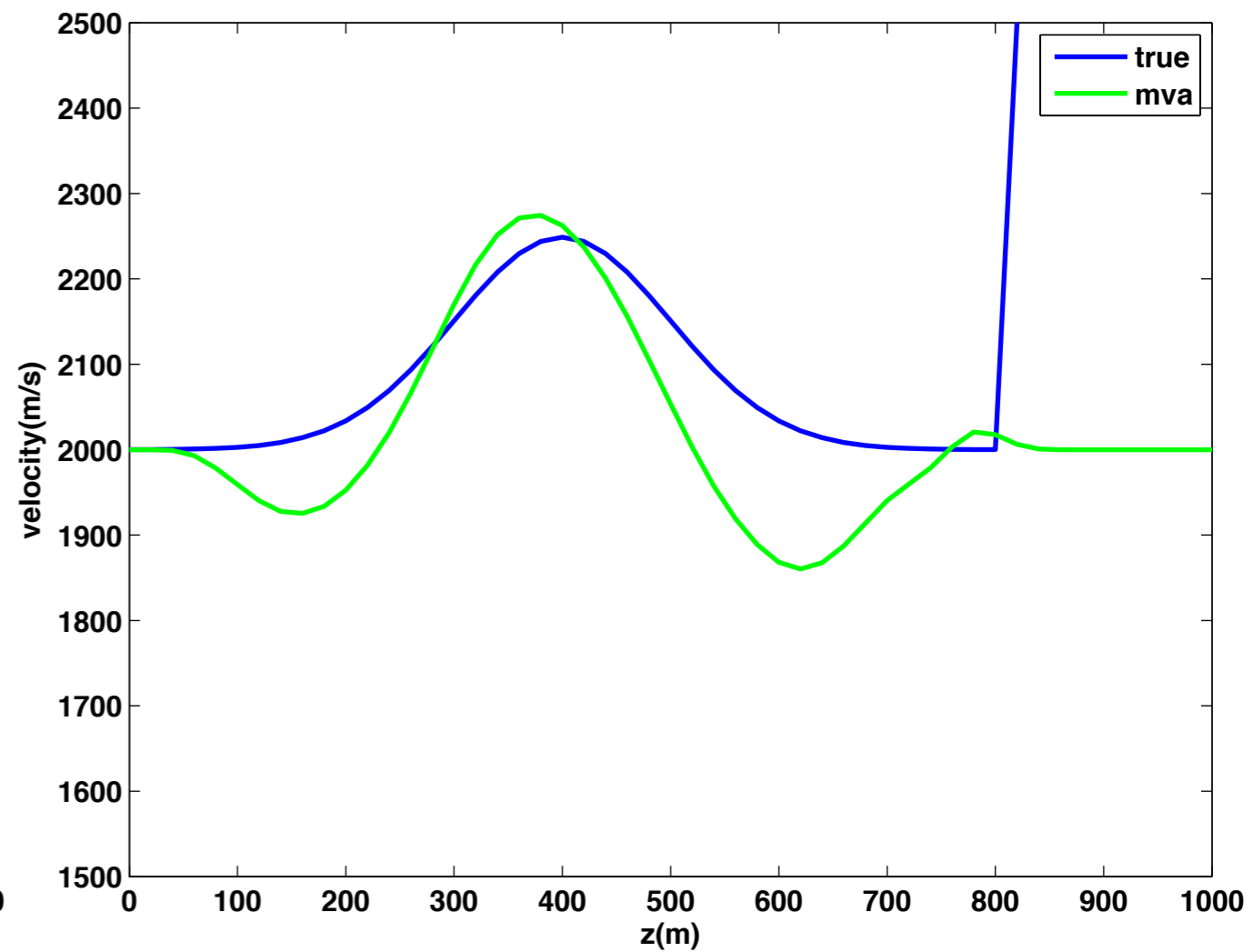


MVA

horizontal trace



vertical trace



Summary

- Use *full* subsurface offsets, no need to estimate *dips a priori*
- *Probe* image volume with *mat-vecs*
- estimate dip *automatically*
- *Suitable* for AVA
- Use techniques from *randomized* trace estimation to compute MVA penalty